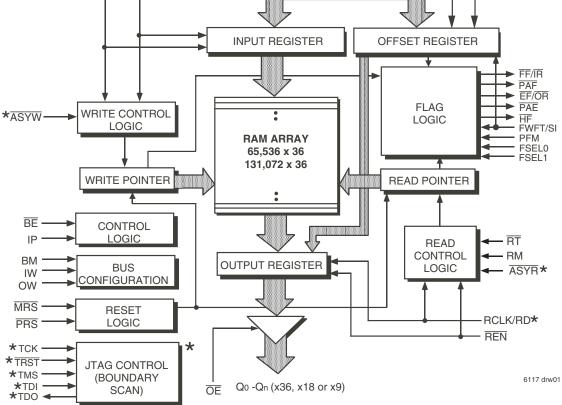
RENESAS	3.3 VOLT HIGH-DENSIT 65,536 x 36 131,072 x 36	Y SUPERSYNC II [™] 36-BIT FIFO 72V36100 72V36110
 FEATURES: Choose among the following memor 72V36100 — 65,536 x 36 72V36110 — 131,072 x 36 Higher density, 2Meg and 4Meg Sup Up to 166 MHz Operation of the Cloce User selectable Asynchronous read and Only) User selectable input and output por x36 in to x36 out x36 in to x18 out x36 in to x36 out x18 in to x36 out x9 in to x36 out Sy input tolerant Fixed, low first word latency Zero latency retransmit Auto power down minimizes standby Master Reset clears data, but retains 	erSync II FIFOs ks //orwriteports(PBGA&CABGA rt bus-sizing able byte representation	 Empty, Full and Half-Full flags signal FIFO status Programmable Almost-Empty and Almost-Full flags, each flag can default to one of eight preselected offsets Selectable synchronous/asynchronous timing modes for Almost-Empty and Almost-Full flags Program programmable flags by either serial or parallel means Select Standard timing (using EF and FF flags) or First Word Fall Through timing (using OR and IR flags) Output enable puts data outputs into high impedance state Easily expandable in depth and width JTAG port, provided for Boundary Scan function (PBGA & CABGA Only) Independent Read and Write Clocks (permit reading and writing simultaneously) Available in a 128-pin Thin Quad Flat Pack (TQFP) or a 144-pin Plastic Ball Grid Array (PBGA) (with additional features), or a 144-pin Chip Array BGA (CABGA) (with additional features) Pin compatible to the SuperSync II (72V3640/72V3650/72V3660/72V3680/72V3690) family High-performance submicron CMOS technology Industrial temperature range (-40°C to +85°C) is available Green parts available, see ordering information

FUNCTIONAL BLOCK DIAGRAM

*Available on the PBGA & CABGA packages only.

Do -Dn (x36, x18 or x9) LD SEN WEN WCLK/WR* INPUT REGISTER OFFSET REGISTER Ŧ FLAG WRITE CONTROL . LOGIC LOGIC **RAM ARRAY** 65,536 x 36 4



COMMERCIAL AND INDUSTRIAL TEMPERATURE RANGES



DESCRIPTION:

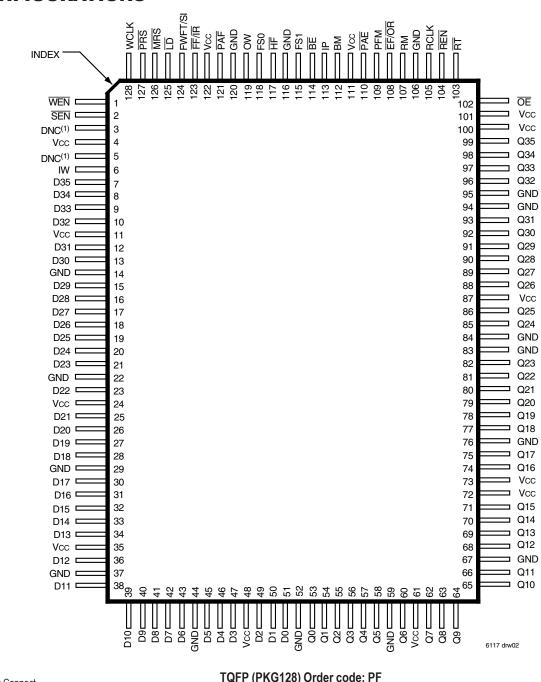
The 72V36100/72V36110 are exceptionally deep, high speed, CMOS First-In-First-Out (FIFO) memories with clocked read and write controls and a flexible Bus-Matching x36/x18/x9 data flow. These FIFOs offer several key user benefits:

- Flexible x36/x18/x9 Bus-Matching on both read and write ports
- The period required by the retransmit operation is fixed and short.
- The first word data latency period, from the time the first word is written to an empty FIFO to the time it can be read, is fixed and short.
- Asynchronous/Synchronous translation on the read or write ports
- High density offerings up to 4 Mbit

Bus-Matching Sync FIFOs are particularly appropriate for network, video, telecommunications, data communications and other applications that need to buffer large amounts of data and match busses of unequal sizes.

Each FIFO has a data input port (Dn) and a data output port (Qn), both of which can assume either a 36-bit, 18-bit or a 9-bit width as determined by the state of external control pins Input Width (IW), Output Width (OW), and Bus-Matching (BM) pin during the Master Reset cycle.

The input port can be selected as either a Synchronous (clocked) interface, or Asynchronous interface. During Synchronous operation the input port is controlled by a Write Clock (WCLK) input and a Write Enable (WEN) input. Data present on the Dn data inputs is written into the FIFO on every rising edge of



PIN CONFIGURATIONS

NOTE: 1. DNC = Do Not Connect.

TQFP (PKG128) Order code: PF

TOP VIEW



DESCRIPTION (CONTINUED)

WCLK when WEN is asserted. During Asynchronous operation only the WR input is used to write data into the FIFO. Data is written on a rising edge of WR, the WEN input should be tied to its active state, (LOW).

The output port can be selected as either a Synchronous (clocked) interface, or Asynchronous interface. During Synchronous operation the output port is controlled by a Read Clock (RCLK) input and Read Enable (\overline{REN}) input. Data is read from the FIFO on every rising edge of RCLK when \overline{REN} is asserted. During Asynchronous operation only the RD input is used to read data from the FIFO. Data is read on a rising edge of RD, the \overline{REN} input should be tied to its

active state, LOW. When Asynchronous operation is selected on the output port the FIFO must be configured for Standard mode, and the \overline{OE} input used to provide three-state control of the outputs, Qn.

The frequencies of both the RCLK and the WCLK signals may vary from 0 to fMAX with complete independence. There are no restrictions on the frequency of the one clock input with respect to the other.

There are two possible timing modes of operation with these devices: Standard mode and First Word Fall Through (FWFT) mode.

In Standard mode, the first word written to an empty FIFO will not appear on the data output lines unless a specific read operation is performed. A read

PIN CONFIGURATIONS (CONTINUED)

	×	— A	1 BALL	PAD COR	NER							
Α	O ASYW	O WEN	O wclk	O PAF	O FF/IR		O BM		O RCLK			O Q35
в	$\frac{O}{\text{SEN}}$	O IW	$\frac{O}{PRS}$		$\frac{O}{MRS}$	O FS0	O FS1	$\frac{O}{ASYR}$	O IP	O PFM	$\frac{O}{RT}$	O Q34
С	O D35	O D34	O D33	O FWFT/SI	O ow	O Vcc	O Vcc		O PAE	O rm	O Q32	() Q3
D	O	O	O	O	O	O	O	O	O	O	O	රී
	D32	D31	D30	Vcc	Vcc	GND	GND	Vcc	Vcc	Q29	Q30	Q31
Е	O	O	0	O	O	O	O	O	O	0	O	O
	D29	D28	D27	Vcc	gnd	GND	GND	GND	Vcc	Q26	Q27	Q28
F	O	O	O	O	O	O	O	O	O	O	O	O
	D26	D25	D24	Vcc	GND	GND	GND	GND	Vcc	Q23	Q24	Q25
G	O	O	O	O	O	O	O	O	O	O	O	O
	D21	D22	D23	Vcc	GND	GND	GND	GND	Vcc	Q22	Q21	Q20
н	O	O	O	O	O	O	O	O	O	O	O	O
	D18	D19	D20	Vcc	gnd	GND	GND	GND	Vcc	Q19	Q18	Q17
J	O	O	O	O	O	O	O	O	O	O	O	O
	D15	D16	D17	Vcc	Vcc	GND	GND	Vcc	Vcc	Q16	Q15	Q14
κ	O	O	O	O	O	O	O	О	O	O	O	O
	D12	D13	D14	D3	D0	Vcc	Vcc	tdo	Q2	Q13	Q12	Q11
L	O	O	O	O	O	О	О	0	О	O	O	()
	D10	D11	D6	D4	D1	тмs	тск	Q0	Q3	Q5	Q10	Q9
М		O D8	O D7	O D5	O D2	O TRST	O TDI	O Q1	O Q4	0 Q6	O Q7	() Q8
	1	2	3	4	5	6	7	8	9	10	11	12 6117 drw02b

CABGA: 1mm pitch, 13mm x 13mm (BCY144) Order code: BCY PBGA: 1mm pitch, 13mm x 13mm (BB144) Order code: BB

TOP VIEW



DESCRIPTION (CONTINUED)

operation, which consists of activating $\overline{\text{REN}}$ and enabling a rising RCLK edge, will shift the word from internal memory to the data output lines.

In *FWFT mode*, the first word written to an empty FIFO is clocked directly to the data output lines after three transitions of the RCLK signal. A REN does not have to be asserted for accessing the first word. However, subsequent words written to the FIFO do require a LOW on REN for access. The state of the FWFT/SI input during Master Reset determines the timing mode in use.

For applications requiring more data storage capacity than a single FIFO can provide, the FWFT timing mode permits depth expansion by chaining FIFOs in series (i.e. the data outputs of one FIFO are connected to the corresponding data inputs of the next). No external logic is required.

These FIFOs have five flag pins, EF/OR (Empty Flag or Output Ready), FF/IR (Full Flag or Input Ready), HF (Half-full Flag), PAE (Programmable Almost-Empty flag) and PAF (Programmable Almost-Full flag). The EF and FF functions are selected in Standard mode. The IR and OR functions are selected in FWFT mode. HF, PAE and PAF are always available for use, irrespective of timing mode.

PAE and PAF can be programmed independently to switch at any point in memory. Programmable offsets determine the flag switching threshold and can be loaded by two methods: parallel or serial. Eight default offsets settings are also provided, so that PAE can be set to switch at a predefined number of locations

from the empty boundary and the \overrightarrow{PAF} threshold can also be set at similar predefined values from the full boundary. The default offset values are set during Master Reset by the state of the FSEL0, FSEL1, and \overrightarrow{LD} pins.

For serial programming, \overline{SEN} together with \overline{LD} on each rising edge of WCLK, are used to load the offset registers via the Serial Input (SI). For parallel programming, \overline{WEN} together with \overline{LD} on each rising edge of WCLK, are used to load the offset registers via Dn. \overline{REN} together with \overline{LD} on each rising edge of RCLK can be used to read the offsets in parallel from Qn regardless of whether serial or parallel offset loading has been selected.

During Master Reset ($\overline{\text{MRS}}$) the following events occur: the read and write pointers are set to the first location of the FIFO. The FWFT pin selects Standard mode or FWFT mode.

The Partial Reset (PRS) also sets the read and write pointers to the first location of the memory. However, the timing mode, programmable flag programming method, and default or programmed offset settings existing before Partial Reset remain unchanged. The flags are updated according to the timing mode and offsets in effect. PRS is useful for resetting a device in mid-operation, when reprogramming programmable flags would be undesirable.

It is also possible to select the timing mode of the \overline{PAE} (Programmable Almost-Empty flag) and \overline{PAF} (Programmable Almost-Full flag) outputs. The timing modes can be set to be either asynchronous or synchronous for the \overline{PAE} and \overline{PAF} flags.

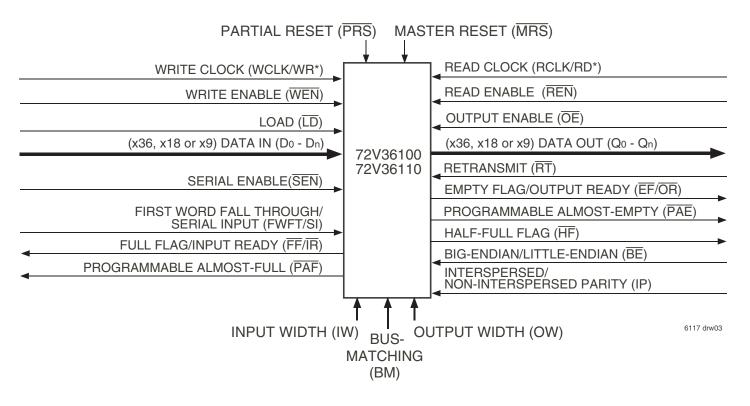


Figure 1. Single Device Configuration Signal Flow Diagram



72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II^ 36-BIT FIFO 65,536 x 36 and 131,072 x 36

If asynchronous PAE/PAF configuration is selected, the PAE is asserted LOW on the LOW-to-HIGH transition of RCLK. PAE is reset to HIGH on the LOW-to-HIGH transition of WCLK. Similarly, the PAF is asserted LOW on the LOW-to-HIGH transition of WCLK and PAF is reset to HIGH on the LOW-to-HIGH transition of RCLK.

If synchronous PAE/PAF configuration is selected, the PAE is asserted and updated on the rising edge of RCLK only and not WCLK. Similarly, PAF is asserted and updated on the rising edge of WCLK only and not RCLK. The mode desired is configured during Master Reset by the state of the Programmable Flag Mode (PFM) pin.

The Retransmit function allows data to be reread from the FIFO more than once. A LOW on the $\overline{\text{RT}}$ input during a rising RCLK edge initiates a retransmit operation by setting the read pointer to the first location of the memory array. A zero-latency retransmit timing mode can be selected using the Retransmit timing Mode pin (RM). During Master Reset, a LOW on RM will select zero latency retransmit. A HIGH on RM during Master Reset will select normal latency.

If zero latency retransmit operation is selected, the first data word to be retransmitted will be placed on the output register with respect to the same RCLK edge that initiated the retransmit based on RT being LOW.

Refer to Figure 11 and 12 for *Retransmit Timing* with normal latency. Refer to Figure 13 and 14 for *Zero Latency Retransmit Timing*.

The device can be configured with different input and output bus widths as shown in Table 1.

A Big-Endian/Little-Endian data word format is provided. This function is useful when data is written into the FIFO in long word format (x36/x18) and read

out of the FIFO in small word (x18/x9) format. If Big-Endian mode is selected, then the most significant byte (word) of the long word written into the FIFO will be read out of the FIFO first, followed by the least significant byte. If Little-Endian format is selected, then the least significant byte of the long word written into the FIFO will be read outfirst, followed by the most significant byte. The mode desired is configured during master reset by the state of the Big-Endian (\overline{BE}) pin. See Figure 4 for *Bus-Matching Byte Arrangement*.

The Interspersed/Non-Interspersed Parity (IP) bit function allows the user to select the parity bit in the word loaded into the parallel port (Do-Dn) when programming the flag offsets. If Interspersed Parity mode is selected, then the FIFO will assume that the parity bit is located in bit positions D8, D17, D26 and D35 during the parallel programming of the flag offsets. If Non-Interspersed Parity mode is selected, then D8, D17 and D26 are assumed to be valid bits and D32, D33, D34 and D35 are ignored. IP mode is selected during Master Reset by the state of the IP input pin. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.

A JTAG test port is provided, here the FIFO has fully functional Boundary Scan feature, compliant with IEEE 1149.1 Standard Test Access Port and Boundary Scan Architecture.

If, at any time, the FIFO is not actively performing an operation, the chip will automatically power down. Once in the power down state, the standby supply current consumption is minimized. Initiating any operation (by activating control inputs) will immediately take the device out of the power down state.

The 72V36100/72V36110 are fabricated using high speed submicron CMOS technology.

TABLE 1 — BUS-MATCHING CONFIGURATION MODES

ВМ	IW	OW	Write Port Width	Read Port Width					
L	L	L	x36	x36					
Н	L	L	x36	x18					
Н	L	Н	x36	x9					
Н	н	L	x18	x36					
Н	Н	Н	x9	x36					

NOTE:

1. Pin status during Master Reset.

PIN DESCRIPTION (TQFP, PBGA, CABGA PACKAGES)

Symbol	Name	I/O	Description
BM ⁽¹⁾	Bus-Matching	Ι	BM works with IW and OW to select the bus sizes for both write and read ports. See Table 1 for bus size configuration.
BE ⁽¹⁾	Big-Endian/ Little-Endian	I	During Master Reset, a LOW on BE will select Big-Endian operation. A HIGH on BE during Master Reset will select Little-Endian format.
D0-D35	Data Inputs	Ι	Data inputs for a 36-, 18- or 9-bit bus. When in 18- or 9-bit mode, the unused input pins are in a don't care state.
EF/OR	Empty Flag/ Output Ready	0	In the Standard mode, the EF function is selected. EF indicates whether or not the FIFO memory is empty. In FWFT mode, the OR function is selected. OR indicates whether or not there is valid data available at the outputs.
FF/IR	Full Flag/ Input Ready	0	In the Standard mode, the FF function is selected. FF indicates whether or not the FIFO memory is full. In the FWFT mode, the IR function is selected. IR indicates whether or not there is space available for writing to the FIFO memory.
FSEL0 ⁽¹⁾	Flag Select Bit 0	I	During Master Reset, this input along with FSEL1 and the $\overline{\text{LD}}$ pin, will select the default offset values for the programmable flags PAE and PAF. There are up to eight possible settings available.
FSEL1 ⁽¹⁾	Flag Select Bit 1	I	During Master Reset, this input along with FSEL0 and the \overline{LD} pin will select the default offset values for the programmable flags PAE and PAF. There are up to eight possible settings available.
FWFT/SI	First Word Fall Through/Serial In	Ι	During Master Reset, selects First Word Fall Through or Standard mode. After Master Reset, this pin functions as a serial input for loading offset registers.
HF	Half-Full Flag	0	HF indicates whether the FIFO memory is more or less than half-full.
IP ⁽¹⁾	Interspersed Parity	I	During Master Reset, a LOW on IP will select Non-Interspersed Parity mode. A HIGH will select Interspersed Parity mode. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.
IW ⁽¹⁾	Input Width		This pin, along with OW and MB, selects the bus width of the write port. See Table 1 for bus size configuration.
LD	Load	Ι	This is a dual purpose pin. During Master Reset, the state of the $\overline{\text{LD}}$ input along with FSEL0 and FSEL1, determines one of eight default offset values for the PAE and PAF flags, along with the method by which these offset registers can be programmed, parallel or serial (see Table 2). After Master Reset, this pin enables writing to and reading from the offset registers.
ŌĒ	Output Enable		OE controls the output impedance of Qn.
OW ⁽¹⁾	OutputWidth	Ι	This pin, along with IW and BM, selects the bus width of the read port. See Table 1 for bus size configuration.
MRS	MasterReset	Ι	MRS initializes the read and write pointers to zero and sets the output register to all zeroes. During Master Reset, the FIFO is configured for either FWFT or Standard mode, Bus-Matching configurations, one of eight programmable flag default settings, serial or parallel programming of the offset settings, Big-Endian/Little-Endian format, zero latency timing mode, interspersed parity, and synchronous versus asynchronous programmable flag timing modes.
PAE	Programmable Almost-Empty Flag	0	PAE goes LOW if the number of words in the FIFO memory is less than offset n, which is stored in the Empty Offset register. PAE goes HIGH if the number of words in the FIFO memory is greater than or equal to offset n.
PAF	Programmable Almost-Full Flag	0	PAF goes HIGH if the number of free locations in the FIFO memory is more than offset m, which is stored in the Full Offset register. PAF goes LOW if the number of free locations in the FIFO memory is less than or equal to m.
PFM ⁽¹⁾	Programmable Flag Mode	I	During Master Reset, a LOW on PFM will select Asynchronous Programmable flag timing mode. A HIGH on PFM will select Synchronous Programmable flag timing mode.
PRS	Partial Reset	Ι	PRS initializes the read and write pointers to zero and sets the output register to all zeroes. During Partial Reset, the existing mode (Standard or FWFT), programming method (serial or parallel), and programmable flag settings are all retained.
Q0-Q35	Data Outputs	0	Data outputs for an 36-, 18- or 9-bit bus. When in 18- or 9- <u>bit m</u> ode, the unused output pins are in a don't care state. Outputs are not 5V tolerant regardless of the state of OE.
RCLK/ RD	Read Clock/ Read Strobe	I	If Synchronous operation of the read port has been selected, when enabled by REN, the rising edge of RCLK reads data from the FIFO memory and offsets from the programmable registers. If LD is LOW, the values loaded into the offset registers is output on a rising edge of RCLK. If Asynchronous operation of the read port has been selected, a rising edge on RD reads data from the FIFO in an Asynchronous manner. REN should be tied LOW. Asynchronous operation of the RCLK/RD input are only available in the PBGA & CABGA packages.
REN	Read Enable	Ι	REN enables RCLK for reading data from the FIFO memory and offset registers.
RM ⁽¹⁾	Retransmit Timing Mode	Ι	During Master Reset, a LOW on RM will select zero latency Retransmit timing Mode. A HIGH on RM will select normal latency mode.
RT	Retransmit	Ι	RT asserted on the rising edge of RCLK initializes the READ pointer to zero, sets the EF flag to LOW (OR to HIGH in FWFT mode) and does not disturb the write pointer, programming method, existing timing mode or programmable flag settings. RT is useful to reread data from the first physical location of the FIFO.

NOTE:

1. Inputs should not change state after Master Reset.



PIN DESCRIPTION-CONTINUED (TQFP, PBGA, CABGA PACKAGES)

Symbol	Name	I/O	Description
SEN	Serial Enable	Ι	SEN enables serial loading of programmable flag offsets.
WCLK/ WR	Write Clock/ Write Strobe	I	If Synchronous operation of the write port has been selected, when enabled by WEN, the rising edge of WCLK writes data into the FIFO. If Asynchronous operation of the write port has been selected, WR writes data into the FIFO on a rising edge in an Asynchronous manner, (WEN should be tied to its active state). Asynchronous operation of the WCLK/WR input are only available in the PBGA & CABGA packages.
WEN	Write Enable	Ι	WEN enables WCLK for writing data into the FIFO memory and offset registers.
Vcc	+3.3V Supply		These are VCC supply inputs and must be connected to the 3.3V supply rail.
NOTE.			

NOTE:

1. Inputs should not change state after Master Reset.

PIN DESCRIPTION (PBGA & CABGA PACKAGES ONLY)

Symbol	Name	I/O	Description
ASYR ⁽¹⁾	Asynchronous Read Port	Ι	A HIGH on this input during Master Reset will select Synchronous read operation for the output port. A LOW will select Asynchronous operation. If Asynchronous is selected the FIFO must operate in Standard mode.
ASYW ⁽¹⁾	Asynchronous Write Port	Ι	A HIGH on this input during Master Reset will select Synchronous write operation for the input port. A LOW will select Asynchronous operation.
TCK ⁽²⁾	JTAGClock	I	Clock input for JTAG function. One of four terminals required by IEEE Standard 1149.1-1990. Test operations of the device are synchronous to TCK. Data from TMS and TDI are sampled on the rising edge of TCK and outputs change on the falling edge of TCK. If the JTAG function is not used this signal needs to be tied to GND.
TDI ⁽²⁾	JTAG Test Data Input		One of four terminals required by IEEE Standard 1149.1-1990. During the JTAG boundary scan operation, test data serially loaded via the TDI on the rising edge of TCK to either the Instruction Register, ID Register and Bypass Register. An internal pull-up resistor forces TDI HIGH if left unconnected.
TDO ⁽²⁾	JTAG Test Data Output	0	One of four terminals required by IEEE Standard 1149.1-1990. During the JTAG boundary scan operation, test data serially loaded output via the TDO on the falling edge of TCK from either the Instruction Register, ID Register and Bypass Register. This output is high impedance except when shifting, while in SHIFT-DR and SHIFT-IR controller states.
TMS ⁽²⁾	JTAG Mode	I	TMS is a serial input pin. One of four terminals required by IEEE Standard 1149.1-1990. TMS directs the device through its TAP controller states. An internal pull-up resistor forces TMS HIGH if left unconnected.
TRST ⁽²⁾	JTAGReset	I	TRST is an asynchronous reset pin for the JTAG controller. The JTAG TAP controller will automatically reset upon power-up. If the JTAG function is not used then this signal should to be tied to GND.

NOTES:

1. Inputs should not change state after Master Reset.

2. These pins are for the JTAG port. Please refer to pages 43-47 and Figures 31-33.



ABSOLUTE MAXIMUM RATINGS

Symbol	Rating	Com'l & Ind'l	Unit
VTERM ⁽²⁾	Terminal Voltage with respect to GND	-0.5 to +4.5	V
Tstg	Storage Temperature	–55 to +125	°C
Ιουτ	DC Output Current	–50 to +50	mA

NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. Vcc terminal only.

RECOMMENDED DC OPERATING CONDITIONS

Symbol	Parameter	Min.	Тур.	Max.	Unit
VCC ⁽¹⁾	Supply Voltage Com'l/Ind'l	3.15	3.3	3.45	V
GND	Supply Voltage Com'l/Ind'l	0	0	0	V
VIH ⁽²⁾	Input High Voltage Com'l/Ind'l	2.0	_	5.5	V
VIL ⁽³⁾	Input Low Voltage Com'l/Ind'l	_	_	0.8	V
TA	Operating Temperature Commercial	0	—	70	°C
TA	Operating Temperature Industrial	-40	_	85	°C

NOTES:

1. Vcc = 3.3V ± 0.15V, JEDEC JESD8-A compliant.

2. Outputs are not 5V tolerant.

3. 1.5V undershoots are allowed for 10ns once per cycle.

DC ELECTRICAL CHARACTERISTICS

(Commercial: Vcc = 3.3V ± 0.15V, TA = 0°C to +70°C; Industrial: Vcc = 3.3V ± 0.15V, TA = -40°C to +85°C; JEDEC JESD8-A compliant)

		72V36100L 72V36110L Commercial and Industrial tcLK = 6, 7-5, 10, 15 ns		
Symbol	Parameter	Min.	Max.	Unit
LI ⁽¹⁾	InputLeakage Current	-1	1	μA
LO ⁽²⁾	Output Leakage Current	-10	10	μA
Vон	Output Logic "1" Voltage, IOH = –2 mA	2.4	—	V
Vol	Output Logic "0" Voltage, IOL = 8 mA	—	0.4	V
ICC1 ^(3,4,5)	Active Power Supply Current	—	40	mA
ICC2 ^(3,6)	StandbyCurrent	—	15	mA

NOTES:

1. Measurements with $0.4 \leq V_{IN} \leq V_{CC}$.

2. $\overline{\text{OE}} \ge \text{ViH}$, $0.4 \le \text{Vout} \le \text{Vcc}$.

3. Tested with outputs open (IOUT = 0).

4. RCLK and WCLK toggle at 20 MHz and data inputs switch at 10 MHz.

5. Typical Icc1 = 4.2 + 1.4*fs + 0.002*CL*fs (in mA) with Vcc = 3.3V, tA = 25°C, fs = WCLK frequency = RCLK frequency (in MHz, using TTL levels), data switching at fs/2, CL = capacitive load (in pF).

6. All Inputs = Vcc - 0.2V or GND + 0.2V, except RCLK and WCLK, which toggle at 20 MHz.

CAPAL		- +23°C, I - 1.0W	пz)	
Symbol	Parameter ⁽¹⁾	Conditions	Max.	Unit
CIN ⁽²⁾	Input Capacitance	$V_{IN} = 0V$	10	pF
COUT ^(1,2)	Output Capacitance	Vout = 0V	10	pF

CAPACITANCE (TA = +25°C, f = 1.0MHz)

NOTES:

1. With output deselected, ($\overline{OE} \ge VIH$).

2. Characterized values, not currently tested.



AC ELECTRICAL CHARACTERISTICS(1)

(Commercial: Vcc = $3.3V \pm 0.15V$, TA = 0°C to +70°C; Industrial: Vcc = $3.3V \pm 0.15V$, TA = -40°C to +85°C; JEDEC JESD8-A compliant)

		Comm	nercial	Com'l CABGA		Comm TQFP	nercial Only		& Ind'l Only	
		72V36 72V36		72V361 72V361		72V36′ 72V36′			100L15 110L15	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
fs	Clock Cycle Frequency	—	166	—	133.3	—	100	—	66.7	MHz
tA	Data Access Time ⁽⁴⁾	1	4	1 ⁽⁴⁾	5	1(4)	6.5	1 ⁽⁴⁾	10	ns
tCLK	Clock Cycle Time	6	—	7.5	—	10	—	15	—	ns
t CLKH	Clock High Time	2.7	—	3.5	—	4.5	—	6	—	ns
t CLKL	Clock Low Time	2.7	—	3.5	—	4.5	—	6	—	ns
tDS	Data Setup Time	2	—	2.5	—	3.5	—	4	—	ns
ťDH	Data Hold Time	0.5	—	0.5	—	0.5	—	1	—	ns
tens	Enable Setup Time	2	—	2.5	—	3.5	—	4	—	ns
t ENH	Enable Hold Time	0.5	—	0.5	—	0.5	—	1	—	ns
tlds	Load Setup Time	3	—	3.5	—	3.5	—	4	—	ns
t ldh	Load Hold Time	0.5	—	0.5	—	0.5	—	1	—	ns
tRS	Reset Pulse Width ⁽²⁾	10	_	10	—	10	—	15	_	ns
tRSS	Reset Setup Time	15	_	15	—	15	—	15	_	ns
t RSR	Reset Recovery Time	10	_	10	—	10	—	15	_	ns
tRSF	Reset to Flag and Output Time	_	15	—	15	—	15	—	15	ns
tRTS	RetransmitSetupTime	3	_	3.5	—	3.5	—	4	_	ns
tolz	Output Enable to Output in Low Z ⁽³⁾	0	_	0	—	0	—	0	_	ns
tOE	Output Enable to Output Valid ⁽⁴⁾	1	4	1(4)	6	1(4)	6	1(4)	8	ns
tohz	Output Enable to Output in High Z ^(3,4)	1	4	1(4)	6	1(4)	6	1(4)	8	ns
tWFF	Write Clock to FF or IR	_	4	-	5	—	6.5	—	10	ns
tREF	Read Clock to EF or OR	_	4	-	5	—	6.5	—	10	ns
t PAFA	Clock to Asynchronous Programmable Almost-Full Flag	_	10	_	12.5	—	16	—	20	ns
t PAFS	Write Clock to Synchronous Programmable Almost-Full Flag	_	4	_	5	—	6.5	_	10	ns
t PAEA	Clock to Asynchronous Programmable Almost-Empty Flag	_	10	—	12.5	—	16	—	20	ns
t PAES	Read Clock to Synchronous Programmable Almost-Empty Flag		4	_	5	_	6.5	—	10	ns
tHF	Clock to HF		10	_	12.5	_	16	—	20	ns
tSKEW1	Skew time between RCLK and WCLK for EF/OR and FF/IR	4	_	5	_	7		9	_	ns
tSKEW2	Skew time between RCLK and WCLK for PAE and PAF	5	_	7	_	10	_	14	_	ns

NOTES:

1. All AC timings apply to both Standard mode and First Word Fall Through mode.

2. Pulse widths less than minimum values are not allowed.

Values guaranteed by design, not currently tested.
 TQFP package only: for speed grades 7-5ns, 10ns and 15ns the minimum for tA, tOE, and tOHZ is 2ns.



AC ELECTRICAL CHARACTERISTICS⁽¹⁾—ASYNCHRONOUS TIMING

(Commercial: Vcc = $3.3V \pm 0.15V$, TA = 0°C to +70°C;Industrial: Vcc = $3.3V \pm 0.15V$, TA = -40°C to +85°C; JEDEC JESD8-A compliant)

·					,	-
		Com	mercial	Com'l		
			100L6		100L7-5	
		72V36	110L6	72V361		
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit
fA ⁽⁴⁾	Cycle Frequency (Asynchronous mode)	—	100	—	83	MHz
taa ⁽⁴⁾	Data Access Time	0.6	8	0.6	10	ns
tCYC ⁽⁴⁾	Cycle Time	10	_	12	—	ns
tCYH ⁽⁴⁾	Cycle HIGH Time	4.5	_	5	—	ns
tCYL ⁽⁴⁾	Cycle LOW Time	4.5	_	5	—	ns
tRPE ⁽⁴⁾	Read Pulse after EF HIGH	8	_	10	—	ns
tffa ⁽⁴⁾	Clock to Asynchronous FF	_	8	_	10	ns
tefa ⁽⁴⁾	Clock to Asynchronous EF	_	8	_	10	ns
tpafa ⁽⁴⁾	Clock to Asynchronous Programmable Almost-Full Flag	_	8	_	10	ns
tPAEA ⁽⁴⁾	Clock to Asynchronous Programmable Almost-Empty Flag	-	8	_	10	ns

NOTES:

1. All AC timings apply to both Standard mode and First Word Fall Through mode.

2. Pulse widths less than minimum values are not allowed.

Values guaranteed by design, not currently tested.
 Parameters apply to the PBGA & CABGA packages only.

AC TEST CONDITIONS

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	3ns ⁽¹⁾
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load for tCLK = 10ns, 15 ns	See Figure 2a
Output Load for tCLK = 6ns, 7.5ns	See Figure 2b & 2c

NOTE:

1. For 166MHz and 133MHz operation input rise/fall times are 1.5ns.

AC TEST LOADS - 6ns, 7.5ns Speed Grade

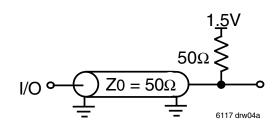


Figure 2b. AC Test Load

AC TEST LOADS - 10ns, 15ns Speed Grades

3.3V 330Ω D.U.T. 510Ω = 30pF* 6117 drw04

Figure 2a. Output Load * Includes jig and scope capacitances.

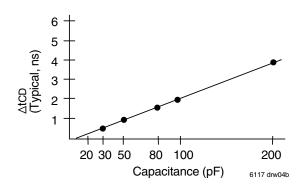
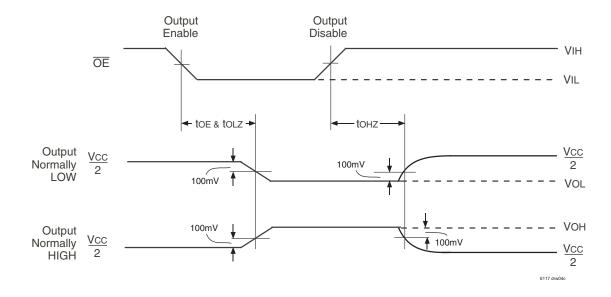


Figure 2c. Lumped Capacitive Load, Typical Derating

OUTPUT ENABLE & DISABLE TIMING





FUNCTIONAL DESCRIPTION

TIMING MODES: STANDARD vs FIRST WORD FALL THROUGH (FWFT) MODE

The 72V36100/72V36110 support two different timing modes of operation: Standard mode or First Word Fall Through (FWFT) mode. The selection of which mode will operate is determined during Master Reset, by the state of the FWFT/SI input.

If, at the time of Master Reset, FWFT/SI is LOW, then Standard mode will be selected. This mode uses the Empty Flag (\overline{EF}) to indicate whether or not there are any words present in the FIFO. It also uses the Full Flag function (\overline{FF}) to indicate whether or not the FIFO has any free space for writing. In Standard mode, every word read from the FIFO, including the first, must be requested using the Read Enable (\overline{REN}) and RCLK.

If, at the time of Master Reset, FWFT/SI is HIGH, then FWFT mode will be selected. This mode uses Output Ready (\overline{OR}) to indicate whether or not there is valid data at the data outputs (Qn). It also uses Input Ready (\overline{IR}) to indicate whether or not the FIFO has any free space for writing. In the FWFT mode, the first word written to an empty FIFO goes directly to Qn after three RCLK rising edges, $\overline{REN} = LOW$ is not necessary. Subsequent words must be accessed using the Read Enable (\overline{REN}) and RCLK.

Various signals, both input and output signals operate differently depending on which timing mode is in effect.

STANDARD MODE

In this mode, the status flags, \overline{FF} , \overline{PAF} , \overline{HF} , \overline{PAE} , and \overline{EF} operate in the manner outlined in Table 3. To write data into to the FIFO, Write Enable (WEN) must be LOW. Data presented to the DATA IN lines will be clocked into the FIFO on subsequent transitions of the Write Clock (WCLK). After the first write is performed, the Empty Flag (\overline{EF}) will go HIGH. Subsequent writes will continue to fill up the FIFO. The Programmable Almost-Empty flag (\overline{PAE}) will go HIGH after n + 1 words have been loaded into the FIFO, where n is the empty offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

If one continued to write data into the FIFO, and we assumed no read operations were taking place, the Half-Full flag ($\overline{\text{HF}}$) would toggle to LOW once the 32,769th word for the 72V36100 and 65,537th word for the 72V36110, respectively was written into the FIFO. Continuing to write data into the FIFO will cause the Programmable Almost-Full flag ($\overline{\text{PAF}}$) to go LOW. Again, if no reads are performed, the $\overline{\text{PAF}}$ will go LOW after (65,536-m) writes for the 72V36100 and (131,072-m) writes for the 72V36110. The offset "m" is the full offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

When the FIFO is full, the Full Flag (\overline{FF}) will go LOW, inhibiting further write operations. If no reads are performed after a reset, \overline{FF} will go LOW after D writes

to the FIFO. D = 65,536 writes for the 72V36100 and 131,072 writes for the 72V36110, respectively.

If the FIFO is full, the first read operation will cause \overline{FF} to go HIGH. Subsequent read operations will cause \overline{PAF} and \overline{HF} to go HIGH at the conditions described in Table 3. If further read operations occur, without write operations, \overline{PAE} will go LOW when there are n words in the FIFO, where n is the empty offset value. Continuing read operations will cause the FIFO to become empty. When the last word has been read from the FIFO, the \overline{EF} will go LOW inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty.

When configured in Standard mode, the EF and FF outputs are double register-buffered outputs.

Relevant timing diagrams for Standard mode can be found in Figure 7,8,11 and 13.

FIRST WORD FALL THROUGH MODE (FWFT)

In this mode, the status flags, \overline{IR} , \overline{PAF} , \overline{HF} , \overline{PAE} , and \overline{OR} operate in the manner outlined in Table 4. To write data into to the FIFO, WEN must be LOW. Data presented to the DATA IN lines will be clocked into the FIFO on subsequent transitions of WCLK. After the first write is performed, the Output Ready (\overline{OR}) flag will go LOW. Subsequent writes will continue to fill up the FIFO. PAE will go HIGH after n + 2 words have been loaded into the FIFO, where n is the empty offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

If one continued to write data into the FIFO, and we assumed no read operations were taking place, the $\overline{\text{HF}}$ would toggle to LOW once the 32,770th word for the 72V36100 and 65,538th word for the 72V36110, respectively was written into the FIFO. Continuing to write data into the FIFO will cause the $\overline{\text{PAF}}$ to go LOW. Again, if no reads are performed, the $\overline{\text{PAF}}$ will go LOW after (65,537-m) writes for the 72V36100 and (131,073-m) writes for the 72V36110, where m is the full offset value. The default setting for these values are stated in the footnote of Table 2.

When the FIFO is full, the Input Ready (\overline{IR}) flag will go HIGH, inhibiting further write operations. If no reads are performed after a reset, \overline{IR} will go HIGH after D writes to the FIFO. D = 65,537 writes for the 72V36100 and 131,073 writes for the 72V36110, respectively. Note that the additional word in FWFT mode is due to the capacity of the memory plus output register.

If the FIFO is full, the first read operation will cause the \overline{IR} flag to go LOW. Subsequent read operations will cause the \overline{PAF} and \overline{HF} to go HIGH at the conditions described in Table 4. If further read operations occur, without write operations, the \overline{PAE} will go LOW when there are n + 1 words in the FIFO, where n is the empty offset value. Continuing read operations will cause the FIFO to become empty. When the last word has been read from the FIFO, \overline{OR} will go HIGH inhibiting further read operations. REN is ignored when the FIFO is empty.

When configured in FWFT mode, the OR flag output is triple registerbuffered, and the IR flag output is double register-buffered.

Relevant timing diagrams for FWFT mode can be found in Figure 9, 10, 12, and 14.

TABLE 2 — DEFAULT PROGRAMMABLEFLAG OFFSETS

72V36100, 72V36110								
ĹD	FSEL1	FSEL0	Offsets n,m					
L	Н	L	16,383					
L	L	Н	8,191					
L	Н	Н	4,095					
Н	Н	L	2,047					
Н	L	L	1,023					
Н	L	Н	511					
Н	Н	Н	255					
L	L	L	127					
LD	FSEL1	FSEL0	Program Mode					
Н	Х	Х	Serial ⁽³⁾					
L	Х	Х	Parallel ⁽⁴⁾					

NOTES:

1. n = empty offset for PAE.

2. m = full offset for PAF.

As well as selecting serial programming mode, one of the default values will also be loaded depending on the state of FSEL0 & FSEL1.

4. As well as selecting parallel programming mode, one of the default values will also be loaded depending on the state of FSEL0 & FSEL1.

PROGRAMMING FLAG OFFSETS

Full and Empty Flag offset values are user programmable. The 72V36100/ 72V36110 have internal registers for these offsets. There are eight default offset values selectable during Master Reset. These offset values are shown in Table 2. Offset values can also be programmed into the FIFO in one of two ways; serial or parallel loading method. The selection of the loading method is done using the \overline{LD} (Load) pin. During Master Reset, the state of the \overline{LD} input determines whether serial or parallel flag offset programming is enabled. A HIGH on \overline{LD} during Master Reset selects serial loading of offset values. ALOW on \overline{LD} during Master Reset selects parallel loading of offset values.

In addition to loading offset values into the FIFO, it is also possible to read the current offset values. Offset values can be read via the parallel output port Q0-Qn, regardless of the programming mode selected (serial or parallel). It is not possible to read the offset values in serial fashion.

Figure 3, Programmable Flag Offset Programming Sequence, summaries the control pins and sequence for both serial and parallel programming modes. For a more detailed description, see discussion that follows.

The offset registers may be programmed (and reprogrammed) any time after Master Reset, regardless of whether serial or parallel programming has been selected. Valid programming ranges are from 0 to D-1.

SYNCHRONOUS vs ASYNCHRONOUS PROGRAMMABLE FLAG TIMING SELECTION

The 72V36100/72V36110 can be configured during the Master Reset cycle with either synchronous or asynchronous timing for \overrightarrow{PAF} and \overrightarrow{PAE} flags by use of the PFM pin.

If synchronous PAF/PAE configuration is selected (PFM, HIGH during MRS), the PAF is asserted and updated on the rising edge of WCLK only and not RCLK. Similarly, PAE is asserted and updated on the rising edge of RCLK only and not WCLK. For detail timing diagrams, see Figure 17 for synchronous PAF timing and Figure 18 for synchronous PAE timing.

If asynchronous PAF/PAE configuration is selected (PFM, LOW during MRS), the PAF is asserted LOW on the LOW-to-HIGH transition of WCLK and PAF is reset to HIGH on the LOW-to-HIGH transition of RCLK. Similarly, PAE is asserted LOW on the LOW-to-HIGH transition of RCLK. PAE is reset to HIGH on the LOW-to-HIGH transition of RCLK. PAE is reset to HIGH on the LOW-to-HIGH transition of WCLK. For detail timing diagrams, see Figure 19 for asynchronous PAE timing and Figure 20 for asynchronous PAE timing.

TABLE 3 — STATUS FLAGS FOR STANDARD MODE

	72V36100	72V36110	FF	PAF	HF	PAE	ĒF
	0	0	Н	н	Н	L	L
Number of	1 to n ⁽¹⁾	1 to n ⁽¹⁾	Н	н	Н	L	Н
Words in	(n+1) to 32,768	(n+1) to 65,536	Н	Н	Н	Н	Н
FIFO	32,769 to (65,536-(m+1))	65,537 to (131,072-(m+1))	Н	Н	L	Н	Н
	(65,536-m) to 65,535	(131,072-m) to 131,071	Н	L	L	Н	Н
	65,536	131,072	L	L	L	Н	Н

NOTE:

1. See table 2 for values for n, m.

TABLE 4 — STATUS FLAGS FOR FWFT MODE

	72V36100	72V36110	ĪR	PAF	HF	PAE	OR
	0	0	L	Н	Н	L	Н
Number of	1 to n+1	1 to n+1	L	Н	Н	L	L
Words in	(n+2) to 32,769	(n+2) to 65,537	L	Н	Н	Н	L
FIFO	32,770 to (65,537-(m+1))	65,538 to (131,073-(m+1))	L	Н	L	Н	L
	(65,537-m) to 65,536	(131,073-m) to 131,072	L	L	L	Н	L
	65,537	131,073	Н	L	L	Н	L

NOTE:

1. See table 2 for values for n, m.

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LD	WEN	REN	SEN	WCLK	RCLK	72V36100 72V36110
0	0	1	1		Х	Parallel write to registers: Empty Offset (LSB) Empty Offset (MSB) Full Offset (LSB) Full Offset (MSB)
0	1	0	1	Х		Parallel read from registers: Empty Offset (LSB) Empty Offset (MSB) Full Offset (LSB) Full Offset (MSB)
0	1	1	0		х	Serial shift into registers: 32 bits for the 72V36100 34 bits for the 72V36110 1 bit for each rising WCLK edge Starting with Empty Offset (LSB) Ending with Full Offset (MSB)
Х	1	1	1	Х	Х	No Operation
1	0	Х	Х		Х	Write Memory
1	Х	0	Х	Х		Read Memory
1	1	1	Х	Х	Х	No Operation
L			1			6117 drw06

NOTES:

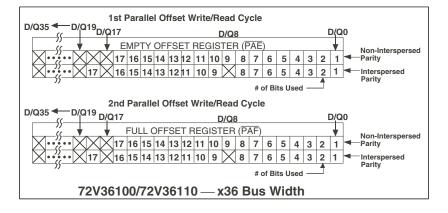
1. The programming method can only be selected at Master Reset.

2. Parallel reading of the offset registers is always permitted regardless of which programming method has been selected.

3. The programming sequence applies to both Standard and FWFT modes.

Figure 3. Programmable Flag Offset Programming Sequence

72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC IIT 36-BIT FIFO 65,536 x 36 and 131,072 x 36



of Bits Used: 16 bits for the 72V36100 17 bits for the 72V36110 Note: All unused bits of the LSB & MSB are don't care

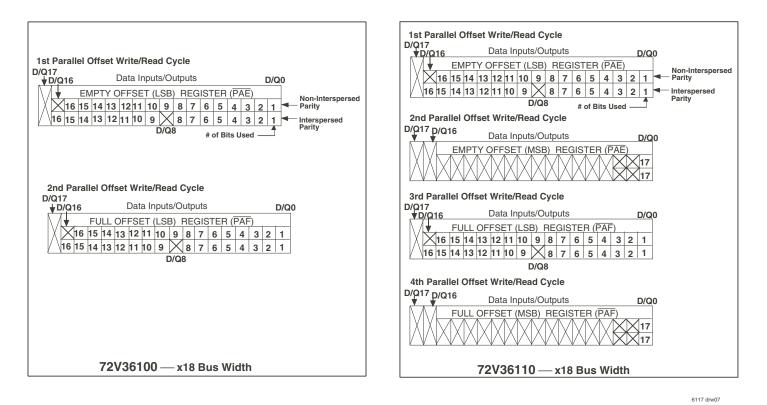


Figure 3. Programmable Flag Offset Programming Sequence (Continued)

72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II™ 36-BIT FIFO 65,536 x 36 and 131,072 x 36

/Q8						_	D/Q0		D/Q8							_	
	EMPTY	OFFS	ET RE	GISTE	R (PA	E)					EMPTY	OFFS	SET RE	GISTE	ER (PA	<u>E)</u>	
8	7	6	5	4	3	2	1			8	7	6	5	4	3	2	.
										arallel	Offset	Write/	Read (Cycle			
									D/Q8					CIETE	ER (PA		D
nd Parallel	Offset	Write/	Read C	vcle												<u>_)</u>	
/Q8				,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			D/Q0			16	15	14	13	12	11	10	
	EMPTY	OFFS	ET RE	GISTE	R (PA	Ē)				V							1
16	15	14	13	12	11	10	9		3rd Pa	arallel (Offset V	Write/I	Read C	ycle			
	15	14	15	12			3		D/Q8_							_	D
												OFFS	SET RE	GISTE	ER (PA	E)	7 -
										$ \times $	$ \times$	$ \times$	-				
										\bigvee						\checkmark	
d Parallel	Offset V	Write/F	Read C	vcle					/th Da	arallel (Writo/	Pood (velo			
/Q8				,			D/Q0		D/Q8		JIISEL	wille/i	ieau c	ycie			D
	FULL	OFFSE	ET REG	SISTER	R (PAF)					FULL	OFFSI	ET REC	GISTE	R (PAF)	
8	7	6	5	4	3	2	1			8	7	6	5	4	3	2	
	-										'	0	5	-	J	2	
									5th Pa	arallel (Jffset	Write/H	Read C	ycle			D
									D/ GO		FULL	OFFSI	FT RF(GISTE	R (PAF	5)	
h Parallel /Q8	Offset \	Write/F	lead C	ycle			D/Q0			16	15	14	13	12	11	10	9
GO	FULL	OFESE	ET REC	SISTER)	D/GU		2	N			1	1	1	1	1
									6th Pa	arallel (Offset \	Write/F	Read C	ycle			
16	15	14	13	12	11	10	9		D/Q8								D
	1		<u> </u>	1	1	1					FULL		ET RE(GISTE	R (PAF	-)	л—
										$ \times $	$ \times $		1				
										\bigvee				\checkmark		\checkmark	
7	2V36	100 -	— x9	Bus V	Width					7	2V36	110	<u> </u>	Bus	Width	h	

16 bits for the 72V36100 17 bits for the 72V36110 Note: All unused bits of the LSB & MSB are don't care

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Figure 3. Programmable Flag Offset Programming Sequence (Continued)

72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II[™] 36-BIT FIFO 65,536 x 36 and 131,072 x 36

SERIAL PROGRAMMING MODE

If Serial Programming mode has been selected, as described above, then programming of PAE and PAF values can be achieved by using a combination of the LD, SEN, WCLK and SI input pins. Programming PAE and PAF proceeds as follows: when LD and SEN are set LOW, data on the SI input are written, one bit for each WCLK rising edge, starting with the Empty Offset LSB and ending with the Full Offset MSB. A total of 32 bits for the 72V36100 and 34 bits for the 72V36110. See Figure 15, Serial Loading of Programmable Flag Registers, for the timing diagram for this mode.

Using the serial method, individual registers cannot be programmed selectively. \overrightarrow{PAE} and \overrightarrow{PAF} can show a valid status only after the complete set of bits (for all offset registers) has been entered. The registers can be reprogrammed as long as the complete set of new offset bits is entered. When \overrightarrow{LD} is LOW and \overrightarrow{SEN} is HIGH, no serial write to the registers can occur.

Write operations to the FIFO are allowed before and during the serial programming sequence. In this case, the programming of all offset bits does not have to occur at once. A select number of bits can be written to the SI input and then, by bringing LD and SEN HIGH, data can be written to FIFO memory via Dn by toggling WEN. When WEN is brought HIGH with LD and SEN restored to a LOW, the next offset bit in sequence is written to the registers via SI. If an interruption of serial programming is desired, it is sufficient either to set LD LOW and deactivate SEN or to set SEN LOW and deactivate LD. Once LD and SEN are both restored to a LOW level, serial offset programming continues.

From the time serial programming has begun, neither programmable flag will be valid until the full set of bits required to fill all the offset registers has been written. Measuring from the rising WCLK edge that achieves the above criteria; PAF will be valid after two more rising WCLK edges plus tPAF, PAE will be valid after the next two rising RCLK edges plus tPAE plus tSKEW2.

It is only possible to read the flag offset values via the parallel output port Qn.

PARALLEL MODE

If Parallel Programming mode has been selected, as described above, then programming of PAE and PAF values can be achieved by using a combination of the LD, WCLK, WEN and Dn input pins. Programming PAE and PAF proceeds as follows: LD and WEN must be set LOW. For x36 bit input bus width, data on the inputs Dn are written into the Empty Offset Register on the first LOWto-HIGH transition of WCLK. Upon the second LOW-to-HIGH transition of WCLK, data are written into the Full Offset Register. The third transition of WCLK writes, once again, to the Empty Offset Register. For x18 bit input bus width, data on the inputs Dn are written into the Empty Offset Register LSB on the first LOW-to-HIGH transition of WCLK. Upon the 2nd LOW-to-HIGH transition of WCLK data are written into the Empty Offset Register MSB. The third transition of WCLK writes to the Full Offset Register LSB, the fourth transition of WCLK then writes to the Full Offset Register MSB. The fifth transition of WCLK writes once again to the Empty Offset Register LSB. A total of four writes to the offset registers is required to load values using a x18 input bus width. For an input bus width of x9 bits, a total of six write cycles to the offset registers is required to load values. See Figure 3, Programmable Flag Offset Programming Sequence. See Figure 16, Parallel Loading of Programmable Flag Registers, for the timing diagram for this mode.

The act of writing offsets in parallel employs a dedicated write offset register pointer. The act of reading offsets employs a dedicated read offset register pointer. The two pointers operate independently; however, a read and a write should not be performed simultaneously to the offset registers. A Master Reset initializes both pointers to the Empty Offset (LSB) register. A Partial Reset has no effect on the position of these pointers.

Write operations to the FIFO are allowed before and during the parallel programming sequence. In this case, the programming of all offset registers does not have to occur at one time. One, two or more offset registers can be written and then by bringing \overline{LD} HIGH, write operations can be redirected to the FIFO memory. When \overline{LD} is set LOW again, and \overline{WEN} is LOW, the next offset register in sequence is written to. As an alternative to holding \overline{WEN} LOW and toggling \overline{LD} , parallel programming can also be interrupted by setting \overline{LD} LOW and toggling \overline{WEN} .

Note that the status of a programmable flag (PAE or PAF) output is invalid during the programming process. From the time parallel programming has begun, a programmable flag output will not be valid until the appropriate offset word has been written to the register(s) pertaining to that flag. Measuring from the rising WCLK edge that achieves the above criteria; PAF will be valid after two more rising WCLK edges plus tPAF, PAE will be valid after the next two rising RCLK edges plus tSKEW2.

The act of reading the offset registers employs a dedicated read offset register pointer. The contents of the offset registers can be read on the Qo-Qn pins when $\overline{\text{LD}}$ is set LOW and $\overline{\text{REN}}$ is set LOW. For x36 output bus width, data are read via Qn from the Empty Offset Register on the first LOW-to-HIGH transition of RCLK. Upon the second LOW-to-HIGH transition of RCLK data are read from the Full Offset Register. The third transition of RCLK reads, once again, from the Empty Offset Register. For x18 output bus width, a total of four read cycles are required to obtain the values of the offset registers. Starting with the Empty Offset Register LSB and finishing with the Full Offset Register MSB. For x9 output bus width, a total of six read cycles must be performed on the offset registers. See Figure 3, *Programmable Flag Offset Programming Sequence*. See Figure 17, *Parallel Read of Programmable Flag Registers*, for the timing diagram for this mode.

It is permissible to interrupt the offset register read sequence with reads or writes to the FIFO. The interruption is accomplished by deasserting $\overline{\text{REN}}$, $\overline{\text{LD}}$, or both together. When $\overline{\text{REN}}$ and $\overline{\text{LD}}$ are restored to a LOW level, reading of the offset registers continues where it left off. It should be noted, and care should be taken from the fact that when a parallel read of the flag offsets is performed, the data word that was present on the output lines Qn will be overwritten.

Parallel reading of the offset registers is always permitted regardless of which timing mode (Standard or FWFT modes) has been selected.

RETRANSMIT OPERATION

The Retransmit operation allows data that has already been read to be accessed again. There are 2 modes of Retransmit operation, normal latency and zero latency. There are two stages to Retransmit: first, a setup procedure that resets the read pointer to the first location of memory, then the actual retransmit, which consists of reading out the memory contents, starting at the beginning of memory.

Retransmit setup is initiated by holding \overline{RT} LOW during a rising RCLK edge. REN and WEN must be HIGH before bringing \overline{RT} LOW. When zero latency is utilized, \overline{REN} does not need to be HIGH before bringing \overline{RT} LOW. At least two words, but no more than D-2 words should have been written into the FIFO, and read from the FIFO, between Reset (Master or Partial) and the time of Retransmit setup. D = 65,537 for the 72V36100 and 131,073 for the 72V36110.

If Standard mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting $\overline{\text{EF}}$ LOW. The change in level will only be noticeable if $\overline{\text{EF}}$ was HIGH before setup. During this period, the internal read pointer is initialized to the first location of the RAM array.

When EF goes HIGH, Retransmit setup is complete and read operations may begin starting with the first location in memory. Since Standard mode is selected, every word read including the first word following Retransmit setup requires a LOW on REN to enable the rising edge of RCLK. See Figure 11, *Retransmit Timing (Standard Mode)*, for the relevant timing diagram.

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If FWFT mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting \overline{OR} HIGH. During this period, the internal read pointer is set to the first location of the RAM array.

When \overline{OR} goes LOW, Retransmit setup is complete; at the same time, the contents of the first location appear on the outputs. Since FWFT mode is selected, the first word appears on the outputs, no LOW on \overline{REN} is necessary. Reading all subsequent words requires a LOW on \overline{REN} to enable the rising edge of RCLK. See Figure 12, *Retransmit Timing (FWFT Mode)*, for the relevant timing diagram.

For either Standard mode or FWFT mode, updating of the \overline{PAE} , \overline{HF} and \overline{PAF} flags begin with the rising edge of RCLK that \overline{RT} is setup. \overline{PAE} is

synchronized to RCLK, thus on the second rising edge of RCLK after \overline{RT} is setup, the \overline{PAE} flag will be updated. \overline{HF} is asynchronous, thus the rising edge of RCLK that \overline{RT} is setup will update \overline{HF} . \overline{PAF} is synchronized to WCLK, thus the second rising edge of WCLK that occurs tSKEW after the rising edge of RCLK that \overline{RT} is setup will update \overline{PAF} . \overline{RT} is synchronized to RCLK.

The Retransmit function has the option of two modes of operation, either "normal latency" or "zero latency". Figure 11 and Figure 12 mentioned previously, relate to "normal latency". Figure 13 and Figure 14 show "zero latency" retransmit operation. Zero latency basically means that the first data word to be retransmitted, is placed onto the output register with respect to the RCLK pulse that initiated the retransmit.

SIGNAL DESCRIPTION

INPUTS:

DATA IN (Do - Dn)

Data inputs for 36-bit wide data (D0 - D35), data inputs for 18-bit wide data (D0 - D17) or data inputs for 9-bit wide data (D0 - D8).

CONTROLS:

MASTER RESET (MRS)

A Master Reset is accomplished whenever the MRS input is taken to a LOW state. This operation sets the internal read and write pointers to the first location of the RAM array. PAE will go LOW, PAF will go HIGH, and HF will go HIGH.

If FWFT/SI is LOW during Master Reset then the Standard mode, along with $\overline{\text{EF}}$ and $\overline{\text{FF}}$ are selected. $\overline{\text{EF}}$ will go LOW and $\overline{\text{FF}}$ will go HIGH. If FWFT/SI is HIGH, then the First Word Fall Through mode (FWFT), along with $\overline{\text{IR}}$ and $\overline{\text{OR}}$, are selected. $\overline{\text{OR}}$ will go HIGH and $\overline{\text{IR}}$ will go LOW.

All control settings such as OW, IW, BM, BE, RM, PFM and IP are defined during the Master Reset cycle.

During a Master Reset, the output register is initialized to all zeroes. A Master Reset is required after power up, before a write operation can take place. $\overline{\text{MRS}}$ is asynchronous.

See Figure 5, Master Reset Timing, for the relevant timing diagram.

PARTIAL RESET (PRS)

A Partial Reset is accomplished whenever the \overline{PRS} input is taken to a LOW state. As in the case of the Master Reset, the internal read and write pointers are set to the first location of the RAM array, \overline{PAE} goes LOW, \overline{PAF} goes HIGH, and \overline{HF} goes HIGH.

Whichever mode is active at the time of Partial Reset, Standard mode or First Word Fall Through, that mode will remain selected. If the Standard mode is active, then \overline{FF} will go HIGH and \overline{EF} will go LOW. If the First Word Fall Through mode is active, then \overline{OR} will go HIGH, and \overline{IR} will go LOW.

Following Partial Reset, all values held in the offset registers remain unchanged. The programming method (parallel or serial) currently active at the time of Partial Reset is also retained. The output register is initialized to all zeroes. PRS is asynchronous.

A Partial Reset is useful for resetting the device during the course of operation, when reprogramming programmable flag offset settings may not be convenient.

See Figure 6, Partial Reset Timing, for the relevant timing diagram.

ASYNCHRONOUS WRITE (ASYW)

The write port can be configured for either Synchronous or Asynchronous mode of operation. If during Master Reset the ASYW input is LOW, then Asynchronous operation of the write port will be selected. During Asynchronous operation of the write port the WCLK input becomes WR input, this is the Asynchronous write strobe input. A rising edge on WR will write data present on the Dn inputs into the FIFO. (WEN must be tied LOW when using the write port in Asynchronous mode).

When the write port is configured for Asynchronous operation the full flag (\overline{FF}) operates in an asynchronous manner, that is, the full flag will be updated based in both a write operation and read operation. Note, if Asynchronous mode is selected, FWFT is not permissable. Refer to Figures 23, 24, 27 and 28 for relevant timing and operational waveforms.

ASYNCHRONOUS READ (ASYR)

The read port can be configured for either Synchronous or Asynchronous mode of operation. If during a Master Reset the ASYR input is LOW, then Asynchronous operation of the read port will be selected. During Asynchronous operation of the read port the RCLK input becomes RD input, this is the Asynchronous read strobe input. A rising edge on RD will read data from the FIFO via the output register and Qn port. (REN must be tied LOW during Asynchronous operation of the read port).

The $\overline{\text{OE}}$ input provides three-state control of the Qn output bus, in an asynchronous manner.

When the read port is configured for Asynchronous operation the device must be operating on standard mode, FWFT mode is not permissible if the read port is Asynchronous. The Empty Flag (\overline{EF}) operates in an Asynchronous manner, that is, the empty flag will be updated based on both a read operation and a write operation. Refer to figures 25, 26, 27 and 28 for relevant timing and operational waveforms.

RETRANSMIT (RT)

The Retransmit operation allows data that has already been read to be accessed again. There are 2 modes of Retransmit operation, normal latency and zero latency. There are two stages to Retransmit: first, a setup procedure that resets the read pointer to the first location of memory, then the actual retransmit, which consists of reading out the memory contents, starting at the beginning of the memory.

Retransmit setup is initiated by holding \overline{RT} LOW during a rising RCLK edge. \overline{REN} and \overline{WEN} must be HIGH before bringing \overline{RT} LOW. When zero latency is utilized, \overline{REN} does not need to be HIGH before bringing \overline{RT} LOW.

If Standard mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting $\overline{\text{EF}}$ LOW. The change in level will only be noticeable if $\overline{\text{EF}}$ was HIGH before setup. During this period, the internal read pointer is initialized to the first location of the RAM array.

When EF goes HIGH, Retransmit setup is complete and read operations may begin starting with the first location in memory. Since Standard mode is selected, every word read including the first word following Retransmit setup requires a LOW on REN to enable the rising edge of RCLK. See Figure 11, *Retransmit Timing (Standard Mode)*, for the relevant timing diagram.

If FWFT mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting \overline{OR} HIGH. During this period, the internal read pointer is set to the first location of the RAM array.

When \overline{OR} goes LOW, Retransmit setup is complete; at the same time, the contents of the first location appear on the outputs. Since FWFT mode is selected, the first word appears on the outputs, no LOW on \overline{REN} is necessary. Reading all subsequent words requires a LOW on \overline{REN} to enable the rising edge of RCLK. See Figure 12, *Retransmit Timing (FWFTMode)*, for the relevant timing diagram.

In Retransmit operation, zero latency mode can be selected using the Retransmit Mode (RM) pin during a Master Reset. This can be applied to both Standard mode and FWFT mode.

FIRST WORD FALL THROUGH/SERIAL IN (FWFT/SI)

This is a dual purpose pin. During Master Reset, the state of the FWFT/ SI input determines whether the device will operate in Standard mode or First Word Fall Through (FWFT) mode.

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If, at the time of Master Reset, FWFT/SI is LOW, then Standard mode will be selected. This mode uses the Empty Flag (\overline{EF}) to indicate whether or not there are any words present in the FIFO memory. It also uses the Full Flag function (\overline{FF}) to indicate whether or not the FIFO memory has any free space for writing. In Standard mode, every word read from the FIFO, including the first, must be requested using the Read Enable (\overline{REN}) and RCLK.

If, at the time of Master Reset, FWFT/SI is HIGH, then FWFT mode will be selected. This mode uses Output Ready (\overline{OR}) to indicate whether or not there is valid data at the data outputs (Qn). It also uses Input Ready (\overline{IR}) to indicate whether or not the FIFO memory has any free space for writing. In the FWFT mode, the first word written to an empty FIFO goes directly to Qn after three RCLK rising edges, \overline{REN} = LOW is not necessary. Subsequent words must be accessed using the Read Enable (\overline{REN}) and RCLK.

After Master Reset, FWFT/SI acts as a serial input for loading PAE and PAF offsets into the programmable registers. The serial input function can only be used when the serial loading method has been selected during Master Reset. Serial programming using the FWFT/SI pin functions the same way in both Standard and FWFT modes.

WRITE STROBE & WRITE CLOCK (WR/WCLK)

If Synchronous operation of the write port has been selected via ASYW, this input behaves as WCLK.

A write cycle is initiated on the rising edge of the WCLK input. Data setup and hold times must be met with respect to the LOW-to-HIGH transition of the WCLK. It is permissible to stop the WCLK. Note that while WCLK is idle, the \overline{FF} /IR, \overline{PAF} and \overline{HF} flags will not be updated. (Note that WCLK is only capable of updating \overline{HF} flag to LOW). The Write and Read Clocks can either be independent or coincident.

If Asynchronous operation has been selected this input is WR (write strobe). Data is Asynchronously written into the FIFO via the Dn inputs whenever there is a rising edge on WR. In this mode the WEN input must be tied LOW.

WRITE ENABLE (WEN)

When the WEN input is LOW, data may be loaded into the FIFO RAM array on the rising edge of every WCLK cycle if the device is not full. Data is stored in the RAM array sequentially and independently of any ongoing read operation.

When WEN is HIGH, no new data is written in the RAM array on each WCLK cycle.

To prevent data overflow in the Standard mode, \overline{FF} will go LOW, inhibiting further write operations. Upon the completion of a valid read cycle, \overline{FF} will go HIGH allowing a write to occur. The \overline{FF} is updated by two WCLK cycles + tskew after the RCLK cycle.

To prevent data overflow in the FWFT mode, \overline{IR} will go HIGH, inhibiting further write operations. Upon the completion of a valid read cycle, \overline{IR} will go LOW allowing a write to occur. The \overline{IR} flag is updated by two WCLK cycles + tskew after the valid RCLK cycle.

WEN is ignored when the FIFO is full in either FWFT or Standard mode. If Asynchronous operation of the write port has been selected, then WEN

If Asynchronous operation of the write port has been selected, then WEN must be held active, (tied LOW).

READ STROBE & READ CLOCK (RD/RCLK)

If Synchronous operation of the read port has been selected via ASYR, this input behaves as RCLK. A read cycle is initiated on the rising edge of the RCLK input. Data can be read on the outputs, on the rising edge of the RCLK input. It is permissible to stop the RCLK. Note that while RCLK is idle, the EF/OR, PAE and HF flags will not be updated. (Note that RCLK is only capable of updating

the $\overline{\text{HF}}\,$ flag to HIGH). The Write and Read Clocks can be independent or coincident.

If Asynchronous operation has been selected this input is RD (Read Strobe). Data is Asynchronously read from the FIFO via the output register whenever there is a rising edge on RD. In this mode the $\overline{\text{REN}}$ input must be tied LOW. The $\overline{\text{OE}}$ input is used to provide Asynchronous control of the three-state Qn outputs.

READ ENABLE (REN)

When Read Enable is LOW, data is loaded from the RAM array into the output register on the rising edge of every RCLK cycle if the device is not empty.

When the REN input is HIGH, the output register holds the previous data and no new data is loaded into the output register. The data outputs Q0-Qn maintain the previous data value.

In the Standard mode, every word accessed at Qn, including the first word written to an empty FIFO, must be requested using \overline{REN} . When the last word has been read from the FIFO, the Empty Flag (\overline{EF}) will go LOW, inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty. Once a write is performed, \overline{EF} will go HIGH allowing a read to occur. The \overline{EF} flag is updated by two RCLK cycles + tSKEW after the valid WCLK cycle.

In the FWFT mode, the first word written to an empty FIFO automatically goes to the outputs Qn, on the third valid LOW-to-HIGH transition of RCLK + tSKEW after the first write. REN does not need to be asserted LOW. In order to access all other words, a read must be executed using REN. The RCLKLOW-to-HIGH transition after the last word has been read from the FIFO, Output Ready (\overline{OR}) will go HIGH with a true read (RCLK with REN = LOW), inhibiting further read operations. REN is ignored when the FIFO is empty.

If Asynchronous operation of the Read port has been selected, then $\overline{\text{REN}}$ must be held active, (tied LOW).

SERIAL ENABLE (SEN)

The $\overline{\text{SEN}}$ input is an enable used only for serial programming of the offset registers. The serial programming method must be selected during Master Reset. $\overline{\text{SEN}}$ is always used in conjunction with $\overline{\text{LD}}$. When these lines are both LOW, data at the SI input can be loaded into the program register one bit for each LOW-to-HIGH transition of WCLK.

When SEN is HIGH, the programmable registers retains the previous settings and no offsets are loaded. SEN functions the same way in both Standard and FWFT modes.

OUTPUT ENABLE (OE)

When Output Enable is enabled (LOW), the parallel output buffers receive data from the output register. When \overline{OE} is HIGH, the output data bus (Qn) goes into a high impedance state.

LOAD (LD)

This is a dual purpose pin. During Master Reset, the state of the \overline{LD} input, along with FSEL0 and FSEL1, determines one of eight default offset values for the \overline{PAE} and \overline{PAF} flags, along with the method by which these offset registers can be programmed, parallel or serial (see Table 2). After Master Reset, \overline{LD} enables write operations to and read operations from the offset registers. Only the offset loading method currently selected can be used to write to the registers. Offset registers can be read only in parallel.

After Master Reset, the $\overline{\text{LD}}$ pin is used to activate the programming process of the flag offset values $\overline{\text{PAE}}$ and $\overline{\text{PAF}}$. Pulling $\overline{\text{LD}}$ LOW will begin a serial loading or parallel load or read of these offset values.

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BUS-MATCHING (BM, IW, OW)

The pins BM, IW and OW are used to define the input and output bus widths. During Master Reset, the state of these pins is used to configure the device bus sizes. See Table 1 for control settings. All flags will operate on the word/byte size boundary as defined by the selection of bus width. See Figure 4 for *Bus-Matching Byte Arrangement*.

BIG-ENDIAN/LITTLE-ENDIAN (BE)

During Master Reset, a LOW on BE will select Big-Endian operation. A HIGH on BE during Master Reset will select Little-Endian format. This function is useful when the following input to output bus widths are implemented: x36 to x18, x36 to x9, x18 to x36 and x9 to x36. If Big-Endian mode is selected, then the most significant byte (word) of the long word written into the FIFO will be read out of the FIFO first, followed by the least significant byte. If Little-Endian format is selected, then the least significant byte of the long word written into the FIFO will be read out first, followed by the most significant byte. The mode desired is configured during master reset by the state of the Big-Endian (BE) pin. See Figure 4 for *Bus-Matching Byte Arrangement*.

PROGRAMMABLE FLAG MODE (PFM)

During Master Reset, a LOW on PFM will select Asynchronous Programmable flag timing mode. A HIGH on PFM will select Synchronous Programmable flag timing mode. If asynchronous PAF/PAE configuration is selected (PFM, LOW during MRS), the PAE is asserted LOW on the LOW-to-HIGH transition of RCLK. PAE is reset to HIGH on the LOW-to-HIGH transition of WCLK. Similarly, the PAF is asserted LOW on the LOW-to-HIGH transition of WCLK and PAF is reset to HIGH on the LOW-to-HIGH transition of RCLK.

If synchronous PAE/PAF configuration is selected (PFM, HIGH during MRS), the PAE is asserted and updated on the rising edge of RCLK only and not WCLK. Similarly, PAF is asserted and updated on the rising edge of WCLK only and not RCLK. The mode desired is configured during master reset by the state of the Programmable Flag Mode (PFM) pin.

INTERSPERSED PARITY (IP)

During Master Reset, a LOW on IP will select Non-Interspersed Parity mode. A HIGH will select Interspersed Parity mode. The IP bit function allows the user to select the parity bit in the word loaded into the parallel port (Do-Dn) when programming the flag offsets. If Interspersed Parity mode is selected, then the FIFO will assume that the parity bits are located in bit position D8, D17, D26 and D35 during the parallel programming of the flag offsets. If Non-Interspersed Parity mode is selected, then D8, D17 and D28 are is assumed to be valid bits and D32, D33, D34 and D35 are ignored. IP mode is selected during Master Reset by the state of the IP input pin. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.

OUTPUTS:

FULL FLAG (FF/IR)

This is a dual purpose pin. In Standard mode, the Full Flag (\overline{FF}) function is selected. When the FIFO is full, \overline{FF} will go LOW, inhibiting further write operations. When \overline{FF} is HIGH, the FIFO is not full. If no reads are performed after a reset (either \overline{MRS} or \overline{PRS}), \overline{FF} will go LOW after D writes to the FIFO (D = 65,536 for the 72V36100 and 131,072 for the 72V36110). See Figure 7, *Write Cycle and Full Flag Timing (Standard Mode)*, for the relevant timing information.

In FWFT mode, the Input Ready (\overline{IR}) function is selected. \overline{IR} goes LOW when memory space is available for writing in data. When there is no longer

any free space left, \overline{IR} goes HIGH, inhibiting further write operations. If no reads are performed after a reset (either \overline{MRS} or \overline{PRS}), \overline{IR} will go HIGH after D writes to the FIFO (D = 65,537 for the 72V36100 and 131,073 for the 72V36110). See Figure 9, *Write Timing (FWFT Mode)*, for the relevant timing information.

The IR status not only measures the contents of the FIFO memory, but also counts the presence of a word in the output register. Thus, in FWFT mode, the total number of writes necessary to deassert \overline{IR} is one greater than needed to assert \overline{FF} in Standard mode.

FF/IR is synchronous and updated on the rising edge of WCLK. FF/IR are double register-buffered outputs.

EMPTY FLAG (EF/OR)

This is a dual purpose pin. In the Standard mode, the Empty Flag (\overline{EF}) function is selected. When the FIFO is empty, \overline{EF} will go LOW, inhibiting further read operations. When \overline{EF} is HIGH, the FIFO is not empty. See Figure 8, *Read Cycle, Empty Flag and First Word Latency Timing (Standard Mode)*, for the relevant timing information.

In FWFT mode, the Output Ready (\overline{OR}) function is selected. \overline{OR} goes LOW at the same time that the first word written to an empty FIFO appears valid on the outputs. \overline{OR} stays LOW after the RCLK LOW to HIGH transition that shifts the last word from the FIFO memory to the outputs. \overline{OR} goes HIGH only with a true read (RCLK with \overline{REN} = LOW). The previous data stays at the outputs, indicating the last word was read. Further data reads are inhibited until \overline{OR} goes LOW again. See Figure 10, *Read Timing (FWFTMode)*, for the relevant timing information.

EF/OR is synchronous and updated on the rising edge of RCLK.

In Standard mode, EF is a double register-buffered output. In FWFT mode, OR is a triple register-buffered output.

PROGRAMMABLE ALMOST-FULL FLAG (PAF)

The Programmable Almost-Full flag (\overline{PAF}) will go LOW when the FIFO reaches the almost-full condition. In Standard mode, if no reads are performed after reset (\overline{MRS}), \overline{PAF} will go LOW after (D - m) words are written to the FIFO. The \overline{PAF} will go LOW after (65,536-m) writes for the 72V36100 and (131,072-m) writes for the 72V36110. The offset "m" is the full offset value. The default setting for this value is stated in the footnote of Table 1.

In FWFT mode, the \overrightarrow{PAF} will go LOW after (65,537-m) writes for the 72V36100 and (131,073-m) writes for the 72V36110, where m is the full offset value. The default setting for this value is stated in Table 2.

See Figure 18, Synchronous Programmable Almost-Full Flag Timing (Standard and FWFT Mode), for the relevant timing information.

If asynchronous PAF configuration is selected, the PAF is asserted LOW on the LOW-to-HIGH transition of the Write Clock (WCLK). PAF is reset to HIGH on the LOW-to-HIGH transition of the Read Clock (RCLK). If synchronous PAF configuration is selected, the PAF is updated on the rising edge of WCLK. See Figure 20, Asynchronous Almost-Full Flag Timing (Standard and FWFT Mode).

PROGRAMMABLE ALMOST-EMPTY FLAG (PAE)

The Programmable Almost-Empty flag (\overline{PAE}) will go LOW when the FIFO reaches the almost-empty condition. In Standard mode, \overline{PAE} will go LOW when there are n words or less in the FIFO. The offset "n" is the empty offset value. The default setting for this value is stated in the footnote of Table 1.

In FWFT mode, the PAE will go LOW when there are n+1 words or less in the FIFO. The default setting for this value is stated in Table 2.

See Figure 19, Synchronous Programmable Almost-Empty Flag Timing (Standard and FWFT Mode), for the relevant timing information.



If asynchronous PAE configuration is selected, the PAE is asserted LOW on the LOW-to-HIGH transition of the Read Clock (RCLK). PAE is reset to HIGH on the LOW-to-HIGH transition of the Write Clock (WCLK). If synchronous PAE configuration is selected, the PAE is updated on the rising edge of RCLK. See Figure 21, Asynchronous Programmable Almost-Empty Flag Timing (Standard and FWFT Mode).

HALF-FULL FLAG (HF)

This output indicates a half-full FIFO. The rising WCLK edge that fills the FIFO beyond half-full sets $\overline{\text{HF}}$ LOW. The flag remains LOW until the difference between the write and read pointers becomes less than or equal to half of the total depth of the device; the rising RCLK edge that accomplishes this condition sets $\overline{\text{HF}}$ HIGH.

In Standard mode, if no reads are performed after reset ($\overline{\text{MRS}}$ or $\overline{\text{PRS}}$), $\overline{\text{HF}}$ will go LOW after (D/2 + 1) writes to the FIFO, where D = 65,536 for the 72V36100 and 131,072 for the 72V36110.

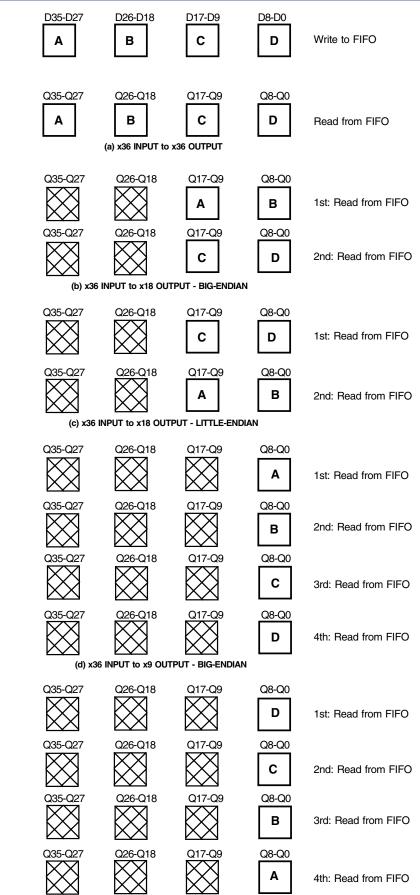
In FWFT mode, if no reads are performed after reset (\overline{MRS} or \overline{PRS}), \overline{HF} will go LOW after (D-1/2 + 2) writes to the FIFO, where D = 65,537 for the 72V36100 and 131,073 for the 72V36110.

See Figure 22, *Half-Full Flag Timing (Standard and FWFT Modes)*, for the relevant timing information. Because HF is updated by both RCLK and WCLK, it is considered asynchronous.

DATA OUTPUTS (Q0-Qn)

(Q0-Q35) are data outputs for 36-bit wide data, (Q0-Q17) are data outputs for 18-bit wide data or (Q0-Q8) are data outputs for 9-bit wide data.





(e) x36 INPUT to x9 OUTPUT - LITTLE-ENDIAN

6117 drw08



BYTE ORDER ON INPUT PORT:

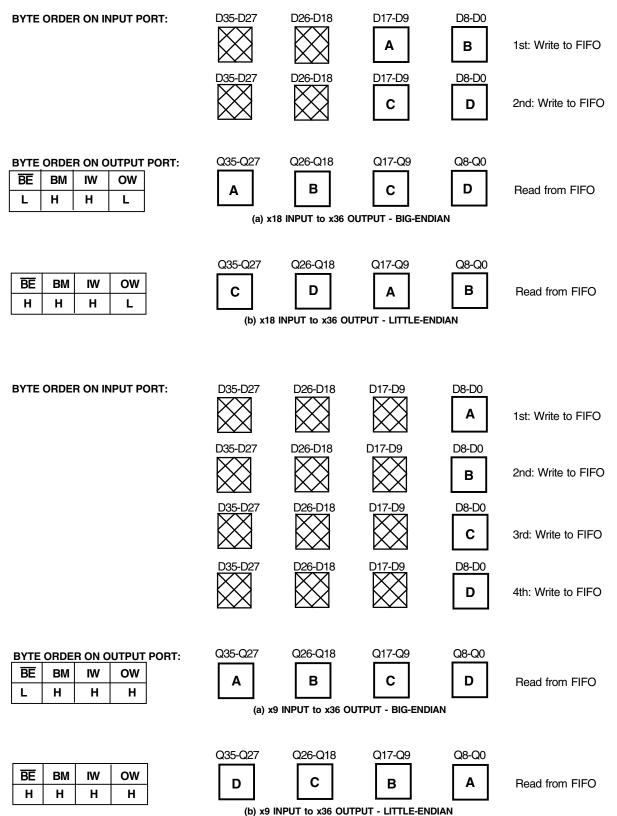
BE	BM	IW	ow
L	н	L	L

ΒĒ	BM	IW	ow
Н	Н	L	L

BE	BM	IW	ow
L	Н	L	Н

BE	BM	IW	ow
н	Н	L	н

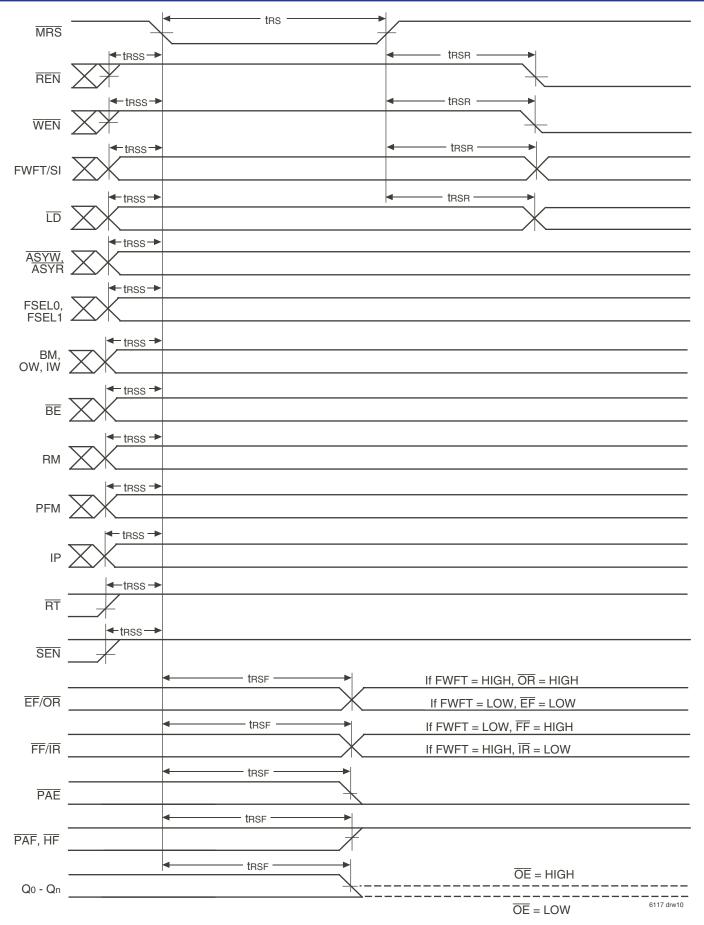


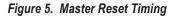


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Figure 4. Bus-Matching Byte Arrangement (Continued)









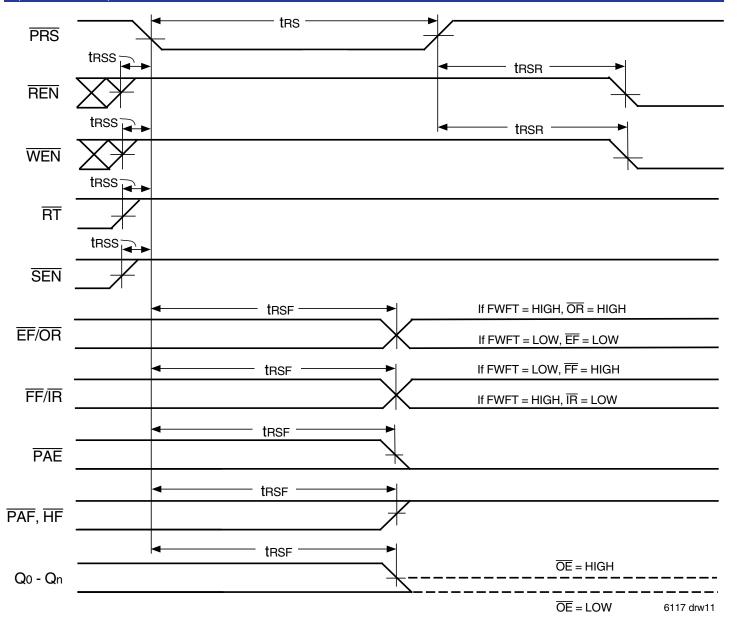
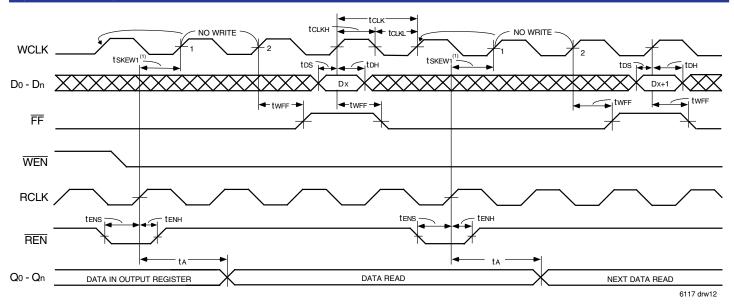


Figure 6. Partial Reset Timing



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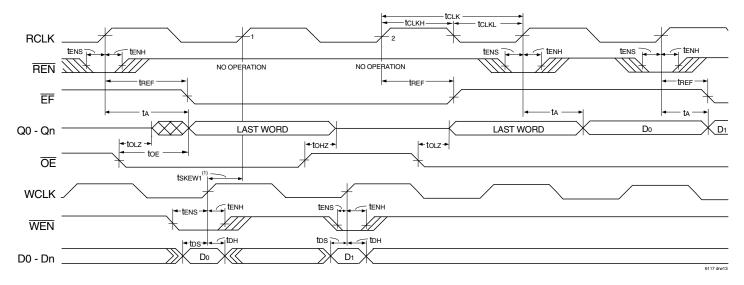


NOTES:

1. tskEw1 is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that FF will go HIGH (after one WCLK cycle pus twFF). If the time between the rising edge of the RCLK and the rising edge of the WCLK is less than tskEw1, then the FF deassertion may be delayed one extra WCLK cycle.

2. $\overline{\text{LD}}$ = HIGH, $\overline{\text{OE}}$ = LOW, $\overline{\text{EF}}$ = HIGH

Figure 7. Write Cycle and Full Flag Timing (Standard Mode)



NOTES:

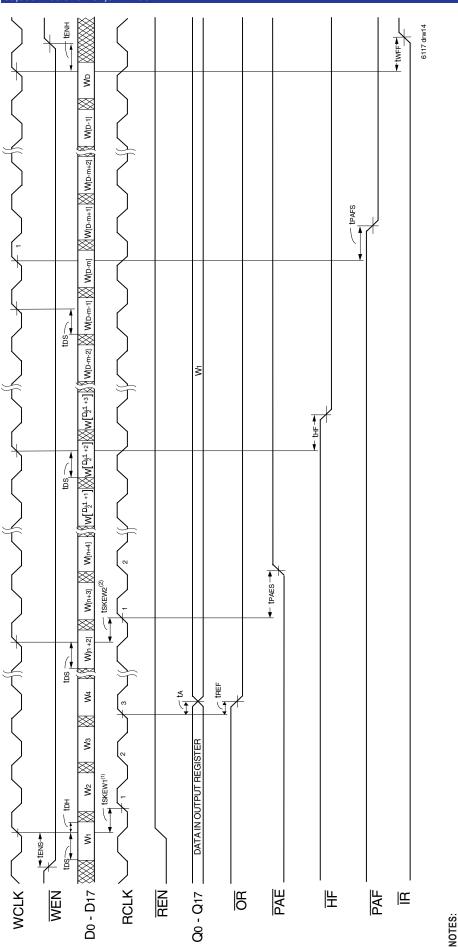
1. tskEw1 is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that EF will go HIGH (after one RCLK cycle plus tREF). If the time between the rising edge of WCLK and the rising edge of RCLK is less than tskEw1, then EF deassertion may be delayed one extra RCLK cycle.

2. LD = HIGH.

3. First data word latency = tskew1 + 1*TRCLK + tREF.

Figure 8. Read Cycle, Empty Flag and First Data Word Latency Timing (Standard Mode)





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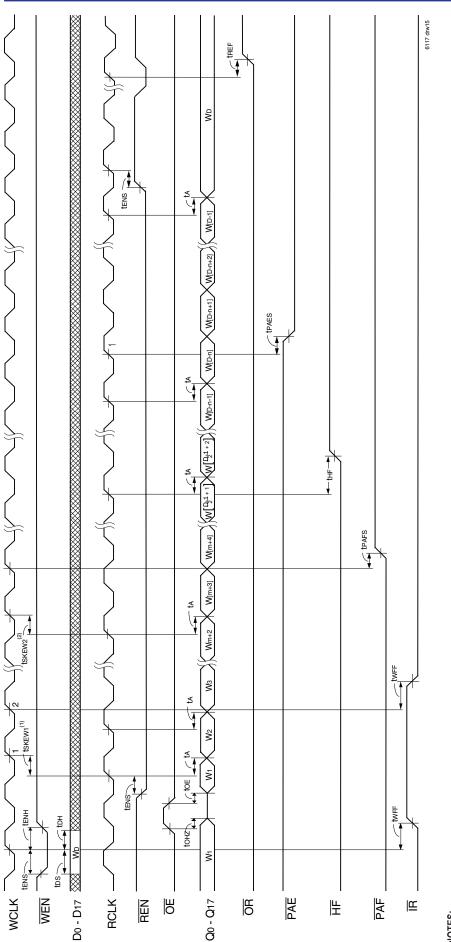
RENESAS

- 1. txkevi is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that OR will go LOW after two RCLK cycles plus tref. If the time between the rising edge of WCLK and the rising edge of RCLK is less than tskew1, then OR assertion may be delayed one extra RCLK cycle.
- tskew2 is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that PAE will go HIGH after one RCLK cycle plus tPAEs. If the time between the rising edge of WCLK and the rising edge of RCLK is less than tskew2, then the PAE deassertion may be delayed one extra RCLK cycle.
 - 3. <u>ID</u> = HIGH, <u>OE</u> = LOW

сi

- 4. $n = \overline{PAE}$ offset, $m = \overline{PAF}$ offset and D = maximum FIFO depth. 5. D = 65,537 for the 72V36100 and 131,073 for the 72V36110. 6. First data word latency = tskew1 + 2*Tac1k + tace

Figure 9. Write Timing (First Word Fall Through Mode)



72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II[™] 36-BIT FIFO

65,536 x 36 and 131,072 x 36

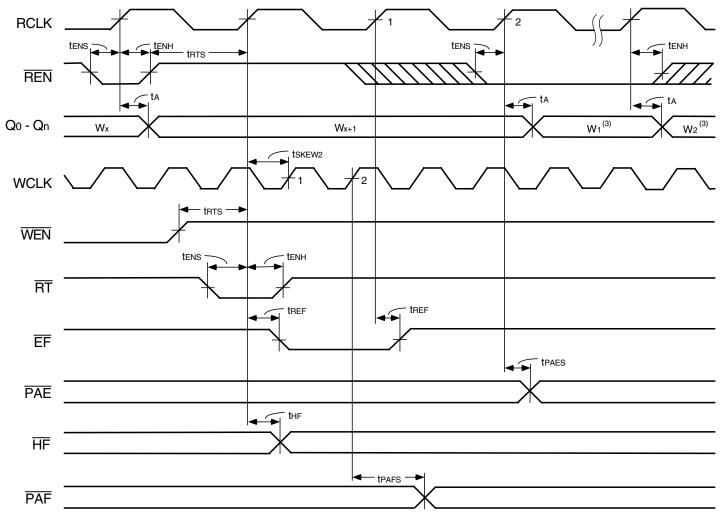
NOTES:

- 1. TKKEW is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that IR will go LOW after one WCLK cycle plus twFF. If the time between the rising edge of RCLK and the rising edge of WCLK is less than tskEw1, then the IR assertion may be delayed one extra WCLK cycle.
- 2. tskew is the minimum time between a rising ROLK edge and a rising WCLK edge to guarantee that PAF will go HIGH after one WCLK cycle plus tPAFs. If the time between the rising edge of RCLK and the rising edge of WCLK is less than tskEw2, then the PAF deassertion may be delayed one extra WCLK cycle
 - <u>ID</u> = HIGH с. С
- 4. n = \overrightarrow{PAE} Offset, m = \overrightarrow{PAF} offset and D = maximum FIFO depth. 5. D = 65,537 for the 72V36100 and 131,073 for the 72V36110.

Figure 10. Read Timing (First Word Fall Through Mode)

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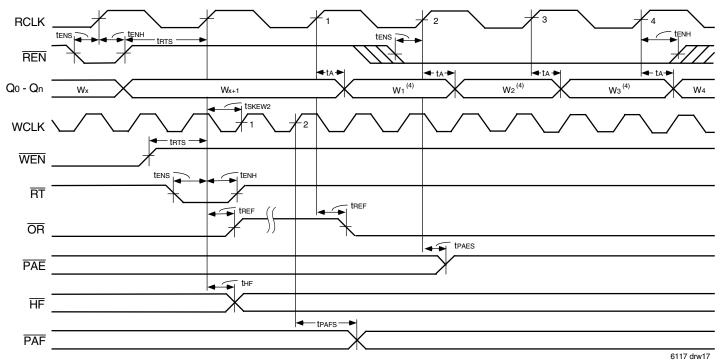
6117 drw16

NOTES:

- 1. Retransmit setup is complete after EF returns HIGH, only then can a read operation begin.
- 2. \overline{OE} = LOW.
- 3. W1 = first word written to the FIFO after Master Reset, W2 = second word written to the FIFO after Master Reset.
- 4. No more than D 2 may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, FF will be HIGH throughout the Retransmit setup procedure. D = 65,536 for the 72V36100 and 131,072 for the 72V36110.
- 5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.
- 6. RM is set HIGH during MRS.

Figure 11. Retransmit Timing (Standard Mode)

72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II[™] 36-BIT FIFO 65,536 x 36 and 131,072 x 36



NOTES:

1. Retransmit setup is complete after \overline{OR} returns LOW.

2. No more than D - 2 words may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, IR will be LOW throughout the Retransmit setup procedure. D = 65,537 for the 72V36100 and 131,073 for the 72V36110.

- 3. $\overline{OE} = LOW$.
- 4. W1, W2, W3 = first, second and third words written to the FIFO after Master Reset.
- 5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.

6. RM is set HIGH during MRS.

Figure 12. Retransmit Timing (FWFT Mode)

72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II™ 36-BIT FIFO 65,536 x 36 and 131,072 x 36

RCLK		2	
REN			
Q0 - Qn	Wx Wx+1 W1 ⁽³⁾	tA W2 ⁽³⁾	tA W3 ⁽³⁾ W4
WCLK		\sim	
WEN			
RT			
ĒF			
PAE		•	tPAES
ĦF			
PAF			6117 drw18

NOTES:

1. If the part is empty at the point of Retransmit, the empty flag (\overline{EF}) will be updated based on RCLK (Retransmit clock cycle), valid data will also appear on the output. 2. \overline{OE} = LOW.

3. W1 = first word written to the FIFO after Master Reset, W2 = second word written to the FIFO after Master Reset.

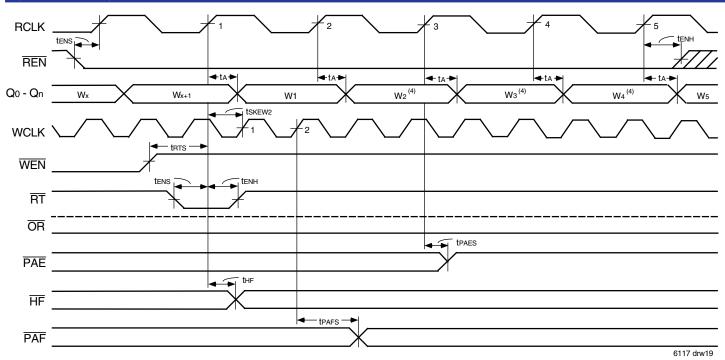
4. No more than D - 2 may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, FF will be HIGH throughout the Retransmit setup procedure. D = 65,536 for the 72V36100 and 131,072 for the 72V36110.

5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.

6. RM is set LOW during MRS.

Figure 13. Zero Latency Retransmit Timing (Standard Mode)

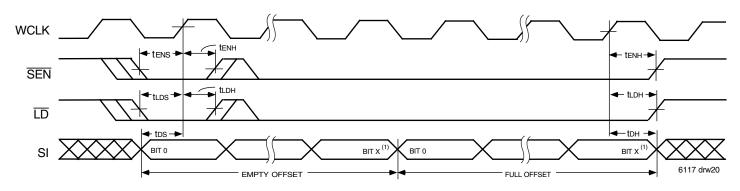
72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II™ 36-BIT FIFO 65,536 x 36 and 131,072 x 36



NOTES:

- 1. If the part is empty at the point of Retransmit, the output ready flag (OR) will be updated based on RCLK (Retransmit clock cycle), valid data will also appear on the output. 2. No more than D - 2 words may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, IR will be LOW throughout the Retransmit setup procedure.
- D = 65,537 for the 72V36100 and 131,073 for the 72V36110.
- 3. \overline{OE} = LOW.
- 4. W1, W2, W3 = first, second and third words written to the FIFO after Master Reset.
- 5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.
- 6. RM is set LOW during MRS.

Figure 14. Zero Latency Retransmit Timing (FWFT Mode)

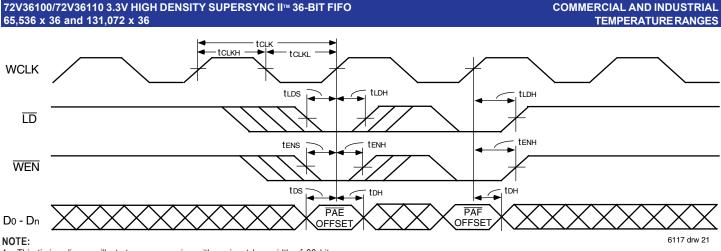


NOTE:

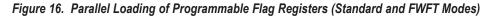
1. X = 15 for the 72V36100 and X = 16 for the 72V36110.

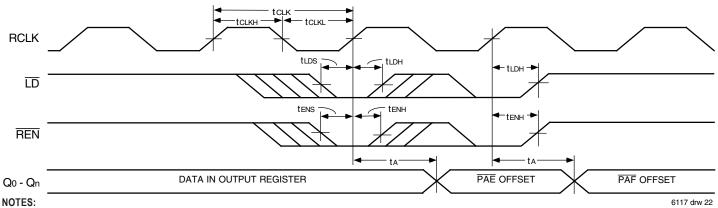
Figure 15. Serial Loading of Programmable Flag Registers (Standard and FWFT Modes)





1. This timing diagram illustrates programming with an input bus width of 36 bits.

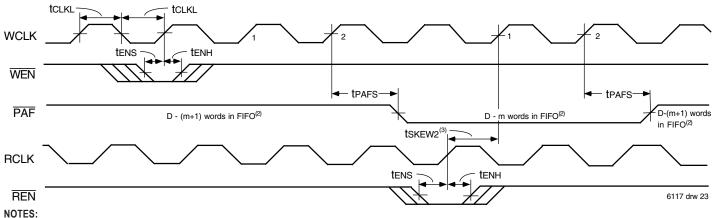




1. \overline{OE} = LOW.

2. The timing diagram illustrates reading of offset registers with an output bus width of 36 bits.





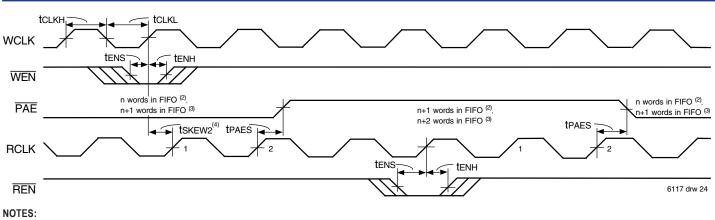
1. m = \overline{PAF} offset.

- 2. D = maximum FIFO depth
- In Standard mode: D = 65,536 for the 72V36100 and 131,072 for the 72V36110.
- In FWFT mode: D = 65,537 for the 72V36100 and 131,073 for the 72V36110.
- tskEw2 is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that PAF will go HIGH (after one WCLK cycle plus tPAFs). If the time between the rising edge of RCLK and the rising edge of WCLK is less than tskEw2, then the PAF deassertion time may be delayed one extra WCLK cycle.
- 4. PAF is asserted and updated on the rising edge of WCLK only.
- 5. Select this mode by setting PFM HIGH during Master Reset.

Figure 18. Synchronous Programmable Almost-Full Flag Timing (Standard and FWFT Modes)



72V36100/72V36110 3.3V HIGH DENSITY SUPERSYNC II™ 36-BIT FIFO 65,536 x 36 and 131,072 x 36

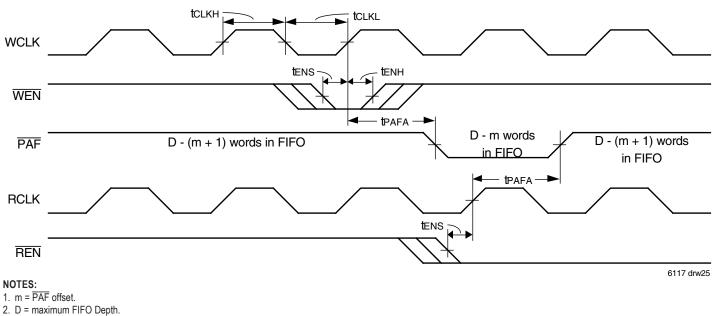


- 1. n = PAE offset.
- 2. For Standard mode
- 3. For FWFT mode.

4. tskew2 is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that PAE will go HIGH (after one RCLK cycle plus tPAEs). If the time between the rising edge of WCLK and the rising edge of RCLK is less than tskew2, then the PAE deassertion may be delayed one extra RCLK cycle.

- 5. PAE is asserted and updated on the rising edge of WCLK only.
- 6. Select this mode by setting PFM HIGH during Master Reset.



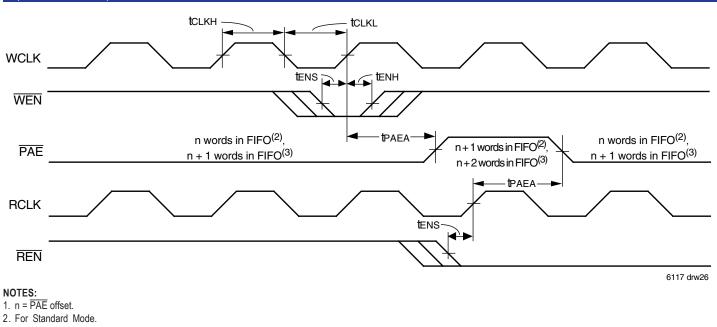


- In Standard Mode: D = 65,536 for the 72V36100 and 131,072 for the 72V36110.
- In FWFT Mode: D = 65,537 for the 72V36100 and 131,073 for the 72V36110.
- 3. PAF is asserted to LOW on WCLK transition and reset to HIGH on RCLK transition.
- 4. Select this mode by setting PFM LOW during Master Reset.

Figure 20. Asynchronous Programmable Almost-Full Flag Timing (Standard and FWFT Modes)

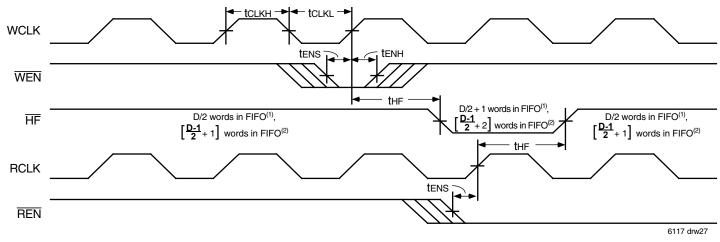






- 3. For FWFT Mode.
- 4. PAE is asserted LOW on RCLK transition and reset to HIGH on WCLK transition.

5. Select this mode by setting PFM LOW during Master Reset.



NOTES:

1. In Standard mode: D = maximum FIFO depth. D = 65,536 for the 72V36100 and 131,072 for the 72V36110.

2. In FWFT mode: D = maximum FIFO depth. D = 65,537 for the 72V36100 and 131,073 for the 72V36110.

Figure 22. Half-Full Flag Timing (Standard and FWFT Modes)



Figure 21. Asynchronous Programmable Almost-Empty Flag Timing (Standard and FWFT Modes)

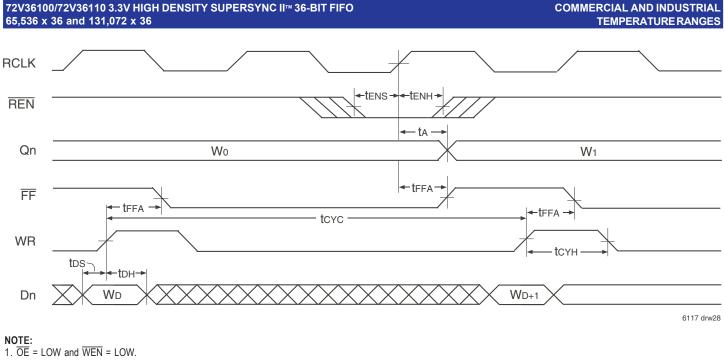
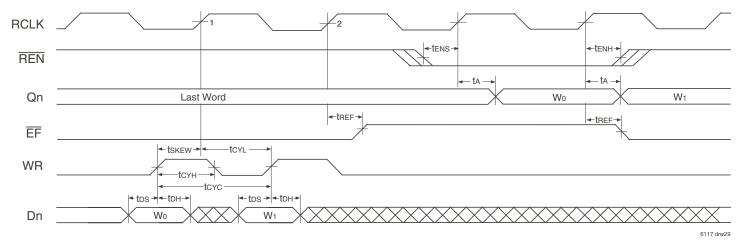


Figure 23. Asynchronous Write, Synchronous Read, Full Flag Operation (Standard Mode)



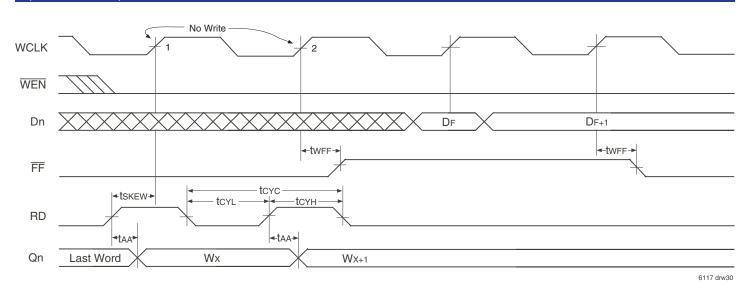
NOTE:

1. \overline{OE} = LOW and \overline{WEN} = LOW.



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RENESAS

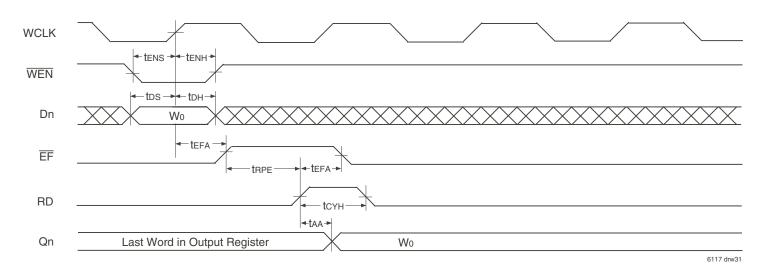


NOTE:

1. \overline{OE} = LOW and \overline{REN} = LOW.

2. Asynchronous Read is available in Standard Mode only.





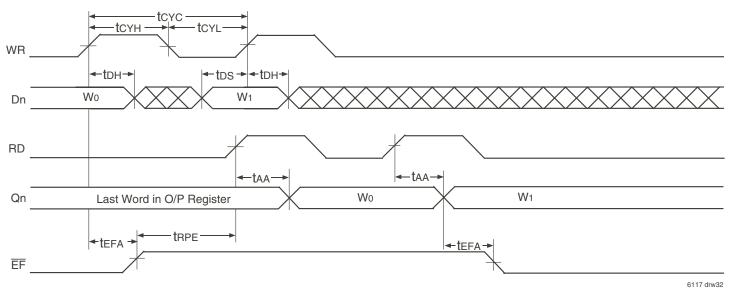
NOTE:

1. \overline{OE} = LOW and \overline{REN} = LOW.

2. Asynchronous Read is available in Standard Mode only.

Figure 26. Synchronous Write, Asynchronous Read, Empty Flag Operation (Standard Mode)



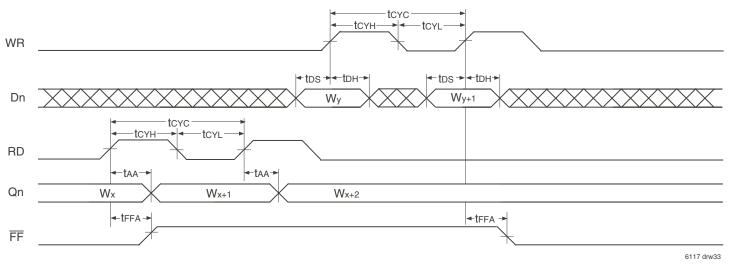


NOTES:

1. \overline{OE} = LOW, \overline{WEN} = LOW, and \overline{REN} = LOW.

2. Asynchronous Read is available in Standard Mode only.





NOTES:

1. \overline{OE} = LOW, \overline{WEN} = LOW, and \overline{REN} = LOW.

2. Asynchronous Read is available in Standard Mode only.

Figure 28. Asynchronous Write, Asynchronous Read, Full Flag Operation (Standard Mode)



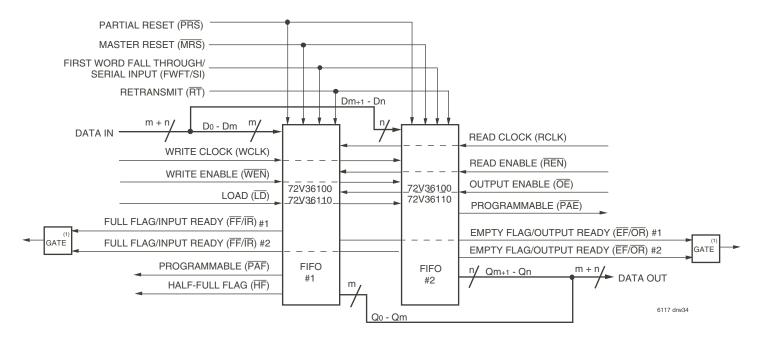
OPTIONAL CONFIGURATIONS

WIDTH EXPANSION CONFIGURATION

Word width may be increased simply by connecting together the control signals of multiple devices. Status flags can be detected from any one device. The exceptions are the $\overline{\text{EF}}$ and $\overline{\text{FF}}$ functions in Standard mode and the $\overline{\text{IR}}$ and $\overline{\text{OR}}$ functions in FWFT mode. Because of variations in skew between RCLK and WCLK, it is possible for $\overline{\text{EF}}/\overline{\text{FF}}$ deassertion and $\overline{\text{IR}}/\overline{\text{OR}}$ assertion to vary

by one cycle between FIFOs. In Standard mode, such problems can be avoided by creating composite flags, that is, ANDing $\overline{\text{EF}}$ of every FIFO, and separately ANDing $\overline{\text{FF}}$ of every FIFO. In FWFT mode, composite flags can be created by ORing $\overline{\text{OR}}$ of every FIFO, and separately ORing $\overline{\text{IR}}$ of every FIFO.

Figure 29 demonstrates a width expansion using two 72V36100/72V36110 devices. D0 - D35 from each device form a 72-bit wide input bus and Q0-Q35 from each device form a 72-bit wide output bus. Any word width can be attained by adding additional 72V36100/72V36110 devices.



NOTES:

- 1. Use an AND gate in Standard mode, an OR gate in FWFT mode.
- 2. Do not connect any output control signals directly together.
- 3. FIFO #1 and FIFO #2 must be the same depth, but may be different word widths.

Figure 29. Block Diagram of 65,536 x 72 and 131,072 x 72 Width Expansion



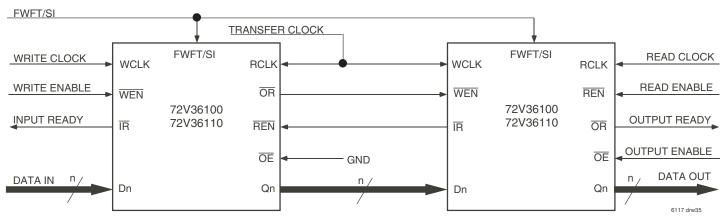


Figure 30. Block Diagram of 131,072 x 36 and 262,144 x 36 Depth Expansion

DEPTH EXPANSION CONFIGURATION (FWFT MODE ONLY)

The 72V36100 can easily be adapted to applications requiring depths greater than 65,536 and 131,072 for the 72V36110, with an 36-bit bus width. In FWFT mode, the FIFOs can be connected in series (the data outputs of one FIFO connected to the data inputs of the next) with no external logic necessary. The resulting configuration provides a total depth equivalent to the sum of the depths associated with each single FIFO. Figure 30 shows a depth expansion using two 72V36100/72V36110 devices.

Care should be taken to select FWFT mode during Master Reset for all FIFOs in the depth expansion configuration. The first word written to an empty configuration will pass from one FIFO to the next ("ripple down") until it finally appears at the outputs of the last FIFO in the chain – no read operation is necessary but the RCLK of each FIFO must be free-running. Each time the data word appears at the outputs of one FIFO, that device's OR line goes LOW, enabling a write to the next FIFO in line.

For an empty expansion configuration, the amount of time it takes for \overline{OR} of the last FIFO in the chain to go LOW (i.e. valid data to appear on the last FIFO's outputs) after a word has been written to the first FIFO is the sum of the delays for each individual FIFO:

(N-1)*(4*transfer clock) + 3*TRCLK

where N is the number of FIFOs in the expansion and TRCLK is the RCLK period. Note that extra cycles should be added for the possibility that the tSKEW1

specification is not met between WCLK and transfer clock, or RCLK and transfer clock, for the \overline{OR} flag.

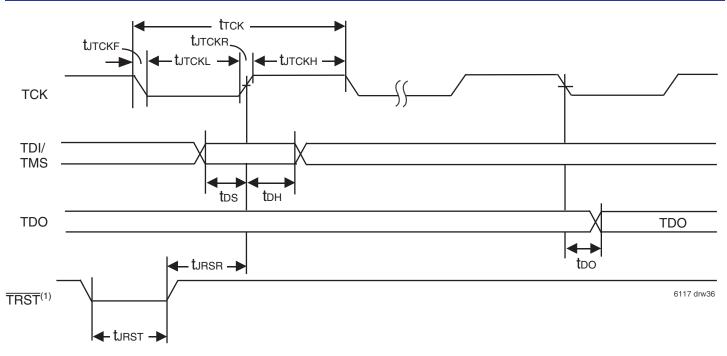
The "ripple down" delay is only noticeable for the first word written to an empty depth expansion configuration. There will be no delay evident for subsequent words written to the configuration.

The first free location created by reading from a full depth expansion configuration will "bubble up" from the last FIFO to the previous one until it finally moves into the first FIFO of the chain. Each time a free location is created in one FIFO of the chain, that FIFO's \overline{IR} line goes LOW, enabling the preceding FIFO to write a word to fill it.

For a full expansion configuration, the amount of time it takes for IR of the first FIFO in the chain to go LOW after a word has been read from the last FIFO is the sum of the delays for each individual FIFO:

where N is the number of FIFOs in the expansion and TWCLK is the WCLK period. Note that extra cycles should be added for the possibility that the tSKEW1 specification is not met between RCLK and transfer clock, or WCLK and transfer clock, for the \overline{IR} flag.

The Transfer Clock line should be tied to either WCLK or RCLK, whichever is faster. Both these actions result in data moving, as quickly as possible, to the end of the chain and free locations to the beginning of the chain.



NOTE:

1. During power up, TRST could be driven low or not be used since the JTAG circuit resets automatically. TRST is an optional JTAG reset.

72V36100 72V36110

Max.

20

-

-

Units

ns

ns

ns

Min.

.

0

10

10



JTAG AC ELECTRICAL CHARACTERISTICS

 $(VCC = 3.3V \pm 5\%; Tcase = 0^{\circ}C \text{ to } +85^{\circ}C)$

Parameter	Symbol	Test			
Farameter	Symbol	Conditions	Min.	Max.	Units
JTAG Clock Input Period	tтск	-	100	-	ns
JTAG Clock HIGH	tյтскн	-	40	-	ns
JTAG Clock Low	t JTCKL	-	40	-	ns
JTAG Clock Rise Time	t JTCKR	-	-	5 ⁽¹⁾	ns
JTAG Clock Fall Time	tjtckf	-	-	5 ⁽¹⁾	ns
JTAGReset	tJRST	-	50	-	ns
JTAG Reset Recovery	tJRSR	-	50	-	ns

NOTE:

1. 50pf loading on external output signals.

Symbol

tDO⁽¹⁾

tDOH⁽¹⁾

tDS

tDΗ

SYSTEM INTERFACE PARAMETERS

Test Conditions

trise=3ns

tfall=3ns

NOTE:

Parameter

Data Output

Data Output Hold

Data Input



^{1.} Guaranteed by design.

Five additional pins (TDI, TDO, TMS, TCK and TRST) are provided to support the JTAG boundary scan interface. The 72V36100/72V36110 incorporates the necessary tap controller and modified pad cells to implement the JTAG facility.

Note that Renesas provides appropriate Boundary Scan Description Language program files for these devices.

The Standard JTAG interface consists of four basic elements:

- Test Access Port (TAP)
- TAP controller

.

- Instruction Register (IR)
- Data Register Port (DR)

The following sections provide a brief description of each element. For a complete description refer to the IEEE Standard Test Access Port Specification (IEEE Std. 1149.1-1990).

The Figure below shows the standard Boundary-Scan Architecture

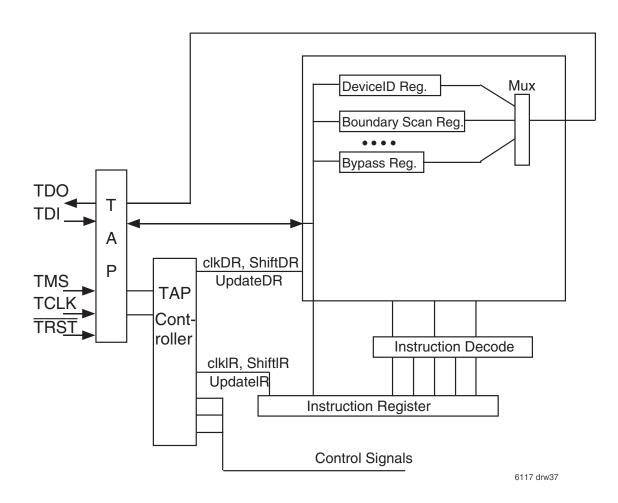


Figure 32. Boundary Scan Architecture

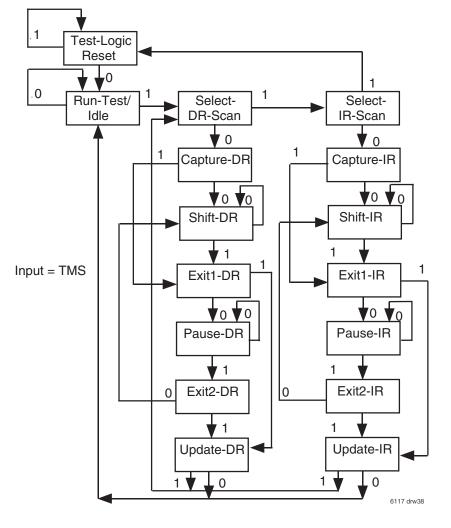
TEST ACCESS PORT (TAP)

The Tap interface is a general-purpose port that provides access to the internal of the processor. It consists of four input ports (TCLK, TMS, TDI, $\overline{\text{TRST}}$) and one output port (TDO).

THE TAP CONTROLLER

The Tap controller is a synchronous finite state machine that responds to TMS and TCLK signals to generate clock and control signals to the Instruction and Data Registers for capture and update of data.





NOTE:

1. Five consecutive TCK cycles with TMS = 1 will reset the TAP



Refer to the IEEE Standard Test Access Port Specification (IEEE Std. 1149.1) for the full state diagram.

All state transitions within the TAP controller occur at the rising edge of the TCLK pulse. The TMS signal level (0 or 1) determines the state progression that occurs on each TCLK rising edge. The TAP controller takes precedence over the Queue and must be reset after power up of the device. See TRST description for more details on TAP controller reset.

Test-Logic-Reset All test logic is disabled in this controller state enabling the normal operation of the IC. The TAP controller state machine is designed in such a way that, no matter what the initial state of the controller is, the Test-Logic-Reset state can be entered by holding TMS at high and pulsing TCK five times. This is the reason why the Test Reset (TRST) pin is optional.

Run-Test-Idle In this controller state, the test logic in the IC is active only if certain instructions are present. For example, if an instruction activates the self test, then it will be executed when the controller enters this state. The test logic in the IC is idles otherwise.

Select-DR-Scan This is a controller state where the decision to enter the Data Path or the Select-IR-Scan state is made.

Select-IR-Scan This is a controller state where the decision to enter the Instruction Path is made. The Controller can return to the Test-Logic-Reset state other wise.

Capture-IR In this controller state, the shift register bank in the Instruction Register parallel loads a pattern of fixed values on the rising edge of TCK. The last two significant bits are always required to be "01".

Shift-IR In this controller state, the instruction register gets connected between TDI and TDO, and the captured pattern gets shifted on each rising edge of TCK. The instruction available on the TDI pin is also shifted in to the instruction register.

Exit1-IR This is a controller state where a decision to enter either the Pause-IR state or Update-IR state is made.

Pause-IR This state is provided in order to allow the shifting of instruction register to be temporarily halted.

Exit2-DR This is a controller state where a decision to enter either the Shift-IR state or Update-IR state is made.

Update-IR In this controller state, the instruction in the instruction register is latched in to the latch bank of the Instruction Register on every falling edge of TCK. This instruction also becomes the current instruction once it is latched.

Capture-DR In this controller state, the data is parallel loaded in to the data registers selected by the current instruction on the rising edge of TCK.

Shift-DR, Exit1-DR, Pause-DR, Exit2-DR and Update-DR These controller states are similar to the Shift-IR, Exit1-IR, Pause-IR, Exit2-IR and Update-IR states in the Instruction path.



THE INSTRUCTION REGISTER

The Instruction register allows an instruction to be shifted in serially into the processor at the rising edge of TCLK.

The Instruction is used to select the test to be performed, or the test data register to be accessed, or both. The instruction shifted into the register is latched at the completion of the shifting process when the TAP controller is at Update-IR state.

The instruction register must contain 4 bit instruction register-based cells which can hold instruction data. These mandatory cells are located nearest the serial outputs they are the least significant bits.

TEST DATA REGISTER

The Test Data register contains three test data registers: the Bypass, the Boundary Scan register and Device ID register.

These registers are connected in parallel between a common serial input and a common serial data output.

The following sections provide a brief description of each element. For a complete description, refer to the IEEE Standard Test Access Port Specification (IEEE Std. 1149.1-1990).

TEST BYPASS REGISTER

The register is used to allow test data to flow through the device from TDI to TDO. It contains a single stage shift register for a minimum length in serial path. When the bypass register is selected by an instruction, the shift register stage is set to a logic zero on the rising edge of TCLK when the TAP controller is in the Capture-DR state.

The operation of the bypass register should not have any effect on the operation of the device in response to the BYPASS instruction.

THE BOUNDARY-SCAN REGISTER

The Boundary Scan Register allows serial data TDI be loaded in to or read out of the processor input/output ports. The Boundary Scan Register is a part of the IEEE 1149.1-1990 Standard JTAG Implementation.

THE DEVICE IDENTIFICATION REGISTER

The Device Identification Register is a Read Only 32-bit register used to specify the manufacturer, part number and version of the processor to be determined through the TAP in response to the IDCODE instruction.

JEDEC ID number is 0xB3. This translates to 0x33 when the parity is dropped in the 11-bit Manufacturer ID field.

For the 72V36100/72V36110, the Part Number field contains the following values:

Device	Part# Field
72V36100	04DE
72V36110	04DF

31(MSB) 28	27 12	11 1	0(LSB)
Version (4 bits)	Part Number (16-bit)	Manufacturer ID (11-bit)	
0X0		0X33	1

72V36100/72V36110 JTAG Device Identification Register

JTAG INSTRUCTION REGISTER

The Instruction register allows instruction to be serially input into the device when the TAP controller is in the Shift-IR state. The instruction is decoded to perform the following:

- Select test data registers that may operate while the instruction is current. The other test data registers should not interfere with chip operation and the selected data register.
- Define the serial test data register path that is used to shift data between TDI and TDO during data register scanning.

The Instruction Register is a 4 bit field (i.e. IR3, IR2, IR1, IR0) to decode 16 different possible instructions. Instructions are decoded as follows.

Hex	Instruction	Function
Value		
0x00	EXTEST	Select Boundary Scan Register
0x02	IDCODE	Select Chip Identification data register
0x01	SAMPLE/PRELOAD	Select Boundary Scan Register
0x03	HIGH-IMPEDANCE	JTAG
0x0F	BYPASS	Select Bypass Register

Table 6. JTA	G Instructior	Register	Decoding
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The following sections provide a brief description of each instruction. For a complete description refer to the IEEE Standard Test Access Port Specification (IEEE Std. 1149.1-1990).

EXTEST

The required EXTEST instruction places the IC into an external boundarytest mode and selects the boundary-scan register to be connected between TDI and TDO. During this instruction, the boundary-scan register is accessed to drive test data off-chip via the boundary outputs and receive test data off-chip via the boundary inputs. As such, the EXTEST instruction is the workhorse of IEEE. Std 1149.1, providing for probe-less testing of solder-joint opens/shorts and of logic cluster function.

IDCODE

The optional IDCODE instruction allows the IC to remain in its functional mode and selects the optional device identification register to be connected between TDI and TDO. The device identification register is a 32-bit shift register containing information regarding the IC manufacturer, device type, and version code. Accessing the device identification register does not interfere with the operation of the IC. Also, access to the device identification register should be immediately available, via a TAP data-scan operation, after power-up of the IC or after the TAP has been reset using the optional TRST pin or by otherwise moving to the Test-Logic-Reset state.

SAMPLE/PRELOAD

The required SAMPLE/PRELOAD instruction allows the IC to remain in a normal functional mode and selects the boundary-scan register to be connected between TDI and TDO. During this instruction, the boundary-scan register can be accessed via a date scan operation, to take a sample of the functional data entering and leaving the IC. This instruction is also used to preload test data into the boundary-scan register before loading an EXTEST instruction.

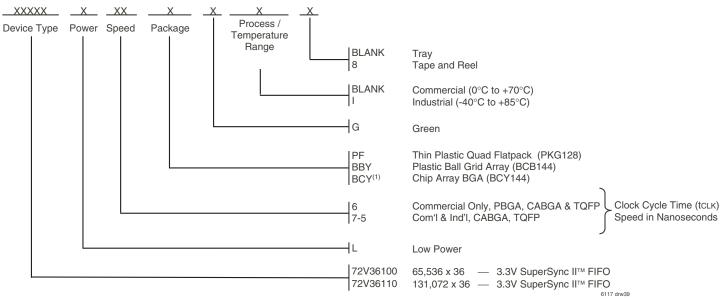
HIGH-IMPEDANCE

The optional High-Impedance instruction sets all outputs (including two-state as well as three-state types) of an IC to a disabled (high-impedance) state and selects the one-bit bypass register to be connected between TDI and TDO. During this instruction, data can be shifted through the bypass register from TDI to TDO without affecting the condition of the IC outputs.

BYPASS

The required BYPASS instruction allows the IC to remain in a normal functional mode and selects the one-bit bypass register to be connected between TDI and TDO. The BYPASS instruction allows serial data to be transferred through the IC from TDI to TDO without affecting the operation of the IC.

ORDERING INFORMATION



NOTES:

1. The BCY package is green.

Note that information regarding recently obsoleted parts is included in this datasheet for customer convenience.

Orderable Part Information

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
6	72V36100L6BCY	BCY144	CABGA	С
	72V36100L6BCY8	BCY144	CABGA	С
	72V36100L6PFG	PKG128	TQFP	С
	72V36100L6PFG8	PKG128	TQFP	С
7-5	72V36100L7-5PFGI	PKG128	TQFP	I
	72V36100L7-5PFGI8	PKG128	TQFP	I

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
6	72V36110L6BCY	BCY144	CABGA	С
	72V36110L6BCY8	BCY144	CABGA	С
	72V36110L6PFG	PKG128	TQFP	С
	72V36110L6BBY	BB144	PBGA	С
	72V36110L6BBY8	BB144	PBGA	С
7-5	72V36110L7-5PFGI	PKG128	TQFP	1
	72V36110L7-5BCY	BCY144	CABGA	С
	72V36110L7-5BCY8	BCY144	CABGA	С
	72V36110L7-5BCYI	BCY144	CABGA	Ι
	72V36110L7-5BCY18	BCY144	CABGA	I

DATASHEET DOCUMENT HISTORY

05/25/2000	pgs. 1, 6, 7, 8, 34, and 35.	07/21/2003 pgs. 7, 43, and 45-47.	
07/28/2000	pgs. 13, 14, and 34.	09/29/2003 pg. 8.	
12/14/2000	pgs. 6, 7, and 8.	11/02/2005 pgs. 1, 8-10, and 48.	
03/27/2001	pg. 7.	04/06/2006 pg. 4.	
04/06/2001	pgs. 4, 5, and 18.	10/22/2008 pg. 48.	
12/14/2001	pgs. 1-36.	12/06/2016 pg. 2, 3, 5, and 48.	
12/16/2002	pgs. 1-11, 20, 21, 26, and 38-47.	03/19/2018 Product Discontinuation Notice - PDN# SP-17-02	2
02/11/2003	pgs. 7, and 45.	Last time buy expires June 15, 2018.	
06/26/2003	pgs. 1, 3, 9, 10, and 47.	03/24/2022 pgs. 1-48.	
07/15/2003	pgs. 3, 20, and 38-40.	05/25/2023 pg. 1, 3, 6, 7, 9, 10 and 48.	

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